

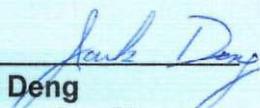
# VERIFICATION OF COMPLIANCE

- **Equipment** : AC-DC Converter
- Model No.** : TMG 30103、TMG 30105、TMG 30112、TMG 30115、TMG 30124
- Applicant** : Traco Electronic AG  
Sihlbruggstrasse 111, 6340 Baar, Switzerland

**I HEREBY****DECLARE THAT :**

The equipment is in accordance with the procedures are given in **EUROPEAN COUNCIL DIRECTIVE 2014/30/EU**. The equipment was **Passed** the test performed according to **European Standard EN 55022:2010/AC:2011 Class B, EN 55032:2012 Class B, EN 61000-3-2:2014, EN 61000-3-3:2013 and EN 55024:2010, EN 61000-6-2:2005 (IEC 61000-4-2 Edition 2.0 2008-12, IEC 61000-4-3 Edition 3.2 2010-04, IEC 61000-4-4 Edition 3.0 2012-04, IEC 61000-4-5 Edition 3.0 2014-05, IEC 61000-4-6 Edition 4.0 2013-10, IEC 61000-4-8 Edition 2.0 2009-09, IEC 61000-4-11 Edition 2.0 2004-03).**

The test was carried out on **Jan. 21, 2016** at **SPORTON INTERNATIONAL INC. LAB.**

  
**Jack Deng**  
Engineering Manager



# CE EMC TEST REPORT

according to

European Standard EN 55022:2010/AC:2011 Class B,  
European Standard EN 55032:2012/AC:2013 Class B,  
EN 61010-3-2:2014, EN 61000-3-3:2013 and  
EN 55024:2010 (IEC 61000-1-2 Edition 2.0 2008-12,  
IEC 61000-4-3 Edition 3.2 2010-04, IEC 61000-4-4 Edition 3.0 2012-04,  
IEC 61000-4-5 Edition 3.0 2014-05, IEC 61000-4-6 Edition 4.0 2013-10,  
IEC 61000-4-8 Edition 2.0 2009-09, IEC 61000-4-11 Edition 2.0 2004-03)

Equipment : AC-DC Converter

Model No. : TMG 30103、TMG 30105、TMG 30112、  
TMG 30115、TMG 3012

Applicant : **Traco Electronic AG**  
Sihlbruggstrasse 111, 6340 Baar, Switzerland

## Statement

- The test result refers exclusively to the test presented test model / sample.
- Without written approval of SPORTON International Inc., the test report shall not be reproduced except in full.
- This test report is only applicable to European Community.



**SPORTON International Inc.**

No. 52, Hwa Ya 1st Rd., Hwa Ya Technology Park, Keelung District, Taoyuan City, Taiwan, R.O.C.



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# VERIFICATION OF COMPLIANCE

according to

**European Standard EN 55022:2010/AC:2011 Class B,  
European Standard EN 55032:2012/AC:2013 Class B,  
EN 61000-3-2:2014, EN 61000-3-3:2013 and  
EN 55024:2010 (IEC 61000-4-2 Edition 2.0 2008-12,  
IEC 61000-4-3 Edition 3.2 2010-04, IEC 61000-4-4 Edition 3.0 2012-04,  
IEC 61000-4-5 Edition 3.0 2014-05, IEC 61000-4-6 Edition 4.0 2013-10,  
IEC 61000-4-8 Edition 2.0 2009-09, IEC 61000-4-11 Edition 2.0 2004-03)**

Equipment : AC-DC Converter

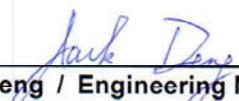
Model No. : TMG 30103 、 TMG 30105 、 TMG 30112 、  
TMG 30115 、 TMG 30124

Applicant : **Traco Electronic AG**  
Sihlbruggstrasse 111, 6340 Baar, Switzerland

## I HEREBY CERTIFY THAT :

The measurements shown in this test report were made in accordance with the procedures given in **EUROPEAN COUNCIL DIRECTIVE 2014/30/EU**. The equipment was *passed* the test performed according to **European Standard EN 55022:2010/AC:2011 Class B, European Standard EN 55032:2012/AC:2013 Class B, EN 61000-3-2:2014, EN 61000-3-3:2013 and EN 55024:2010 (IEC 61000-4-2 Edition 2.0 2008-12, IEC 61000-4-3 Edition 3.2 2010-04, IEC 61000-4-4 Edition 3.0 2012-04, IEC 61000-4-5 Edition 3.0 2014-05, IEC 61000-4-6 Edition 4.0 2013-10, IEC 61000-4-8 Edition 2.0 2009-09, IEC 61000-4-11 Edition 2.0 2004-03)**.

The product sample received on Dec. 21, 2015 and completely tested on Jan. 21, 2016 at **SPORTON International Inc. LAB.**

  
Jack Deng / Engineering Manager

**SPORTON International Inc.**

No. 52, Hwa Ya 1st Rd., Hwa Ya Technology Park, Kwei-Shan District, Taoyuan City, Taiwan, R.O.C.



## **1. General Description of Equipment under Test**

### **1.1. Applicant**

Traco Electronic AG  
Sihlbruggstrasse 111, 6340 Baar, Switzerland

### **1.2. Manufacturer**

Traco Electronic AG  
Sihlbruggstrasse 111, 6340 Baar, Switzerland

### **1.3. Basic Description of Equipment under Test**

Equipment : AC-DC Converter  
Model No. : TMG 30103 、 TMG 30105 、 TMG 30112 、 TMG 30115 、 TMG 30124  
Trade Name : TRACO  
Power Supply Type : From Adapter (Switching)  
AC Power Cord : Non-Shielded, 1.2 m, 2 pin

### **1.4. Feature of Equipment under Test**

Please refer to user manual.

## 2. Test Configuration of Equipment under Test

### 2.1. Test Manner

- a. During testing, the interface cables and equipment positions were varied according to European Standard EN 55022, EN 55032 and EN55024.
- b. The equipment under test were performed the following test modes:

Test Items	Description of test modes
AC Conducted Emission	Mode 1. Full Load
Radiated Emissions	Mode 1. Full Load
Harmonic and Flicker Emissions	Mode 1. Full Load
EMS	Mode 1. Full Load

- c. Frequency range investigated: Conduction 150 kHz to 30 MHz, Radiation 30 MHz to 1,000 MHz.
- d. Frequency range investigated immunity test: CS 150 kHz to 80 MHz, RS 80 MHz to 1,000 MHz.



## 2.2. Description of Test System

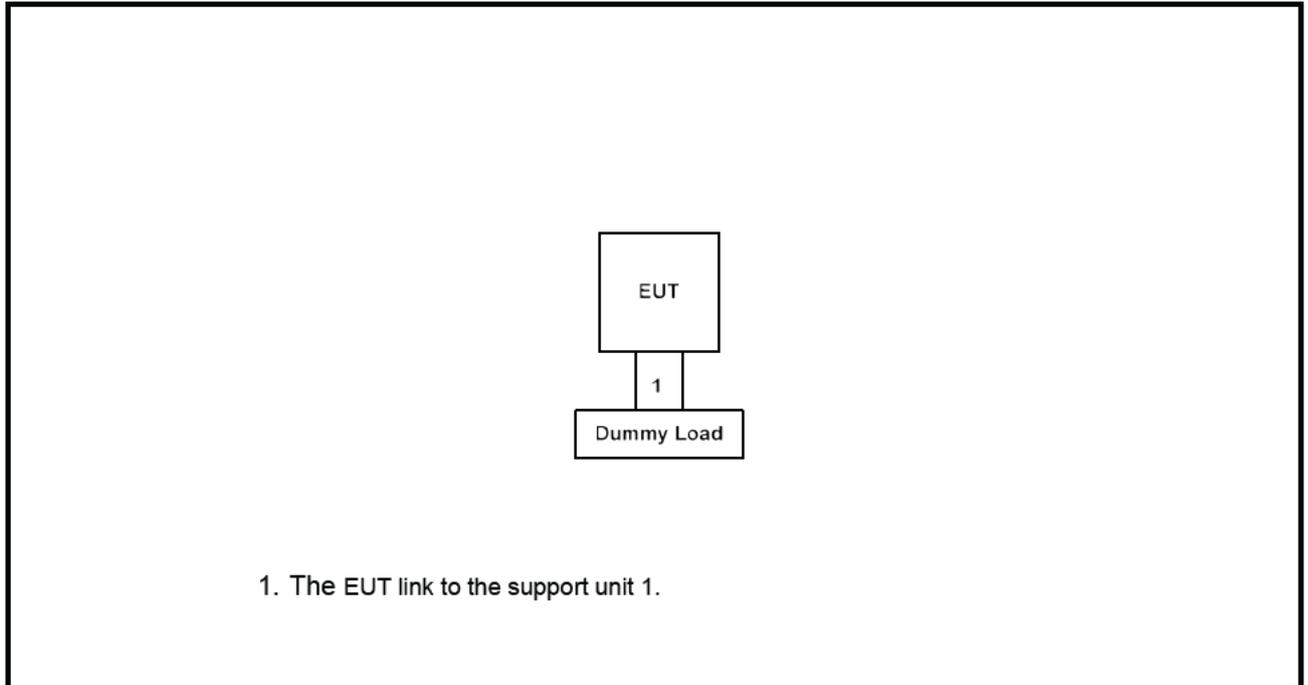
<For conducted emission and radiated emission below 1GHz >

No.	Peripheral	Manufacturer	Model Number	Cable / Spec. Description
Local				
1	Dummy Load	██████	4.8Ω/30W	---

< EMS >

No.	Peripheral	Manufacturer	Model Number	Cable / Spec. Description
Local				
1	Dummy Load	██████	4.8Ω/30W	---
2	Multimeter	YU FONG	YF-303	Probe Cable, Non-Shielded, 1.0m

### 2.3. Connection Diagram of Test System for Radiated Emission





### **3. Test Software**

No test software was used during testing.



## **4. General Information of Test**

### **4.1. Test Facility**

**<EMI>**

**Test Site : SPORTON INTERNATIONAL INC.**

Test Site Location : No. 3, Lane 238, Kangle St., Neihu Chiu, Taipei, Taiwan 114, R.O.C.  
TEL : 886-2-2631-5551  
FAX : 886-2-2631-9740

Test Site No. : CO01-NH, OS03-NH

**<EMS>**

Test Site Location : No. 52, Hwa Ya 1st Rd., Hwa Ya Technology Park, Kwei-Shan District,  
Taoyuan City, Taiwan, R.O.C.  
TEL : 886-3-327-3456  
FAX : 886-3-327-0973

### **4.2. Test Voltage**

AC 230V / 50Hz

### **4.3. Measurement Procedure**

EMI Test : European Standard EN 55022 Class B  
European Standard EN 55032 Class B  
Harmonics Test : European Standard EN 61000-3-2  
Voltage Fluctuations Test : European Standard EN 61000-3-3  
EMS Test : European Standard EN 55024  
(ESD: IEC 61000-4-2, RS: IEC 61000-4-3, EFT: IEC 61000-4-4, SURGE: IEC 61000-4-5,  
CS: IEC 61000-4-6, Power Frequency Magnetic Field: IEC 61000-4-8, DIPS: IEC 61000-4-11)

### **4.4. Test in Compliance with**

EMI Test : European Standard EN 55022 Class B  
European Standard EN 55032 Class B  
Harmonics Test : European Standard EN 61000-3-2  
Voltage Fluctuations Test : European Standard EN 61000-3-3  
EMS Test : European Standard EN 55024  
(ESD: IEC 61000-4-2, RS: IEC 61000-4-3, EFT: IEC 61000-4-4, SURGE: IEC 61000-4-5,  
CS: IEC 61000-4-6, Power Frequency Magnetic Field: IEC 61000-4-8, DIPS: IEC 61000-4-11)



#### **4.5. Frequency Range Investigated**

- a. Conducted emission test: from 150 kHz to 30 MHz
- b. Radiated emission test: from 30 MHz to 1,000 MHz
- c. Radio frequency electromagnetic field immunity test: 80-1000 MHz

#### **4.6. Test Distance**

- a. The test distance of radiated emission test from antenna to EUT is 10 M (from 30MHz~1GHz).
- b. The test distance of radio frequency electromagnetic field immunity test from antenna to EUT is 3 M.



## **5. Conducted Emissions Measurement\_For EN 55022**

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55022 Clause 9. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meter above the ground plane. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

### **5.1. Test Procedures**

- a. The EUT was warmed up for 15 minutes before testing started.
- b. The EUT was placed on a desk 0.8 meter height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meter from any other grounded conducting surface.
- c. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- d. Connect Telecommunication port to ISN (Impedance Stabilization Network).
- e. All the support units are connect to the other LISN.
- f. The LISN provides 50 ohm, coupling impedance for the measuring instrument.
- g. The CISPR states that a 50 ohm, 50 microhenry LISN should be used.
- h. Both sides of AC line were checked for maximum conducted interference.
- i. The frequency range from 150 kHz to 30 MHz was searched.
- j. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.



## **5.2. Typical Test Setup Layout of AC Powerline Conducted Emissions**

- a. AMN is 80 cm from the EUT and at least 80 cm from other units and other metal planes.
- b. EUT is connected to one artificial mains network (AMN).
- c. All other units of a system are powered from a second AMN. A multiple outlet strip can be used for multiple mains cords.
- d. Rear of EUT to be flushed with rear of table top.
- e. Peripherals shall be placed at a distance of 10 cm from each other and from the controller, except for the monitor which, if this is an acceptable installation practice, shall be placed directly on the top of the controller.
- f. If cables, which hang closer than 40 cm to the horizontal metal ground plane, cannot be shortened to appropriate length, the excess shall be folded back and forth forming a bundle 30 cm to 40 cm long.
- g. Mains cords and signal cables shall be positioned for their entire lengths, as far as possible, at 40 cm from the vertical reference plane.
- h. Cables of hand operated devices, such as keyboards, mice, etc. shall be placed as for normal usage.



### **5.3. Typical Test Setup Layout of Disturbance at Telecommunication Ports**

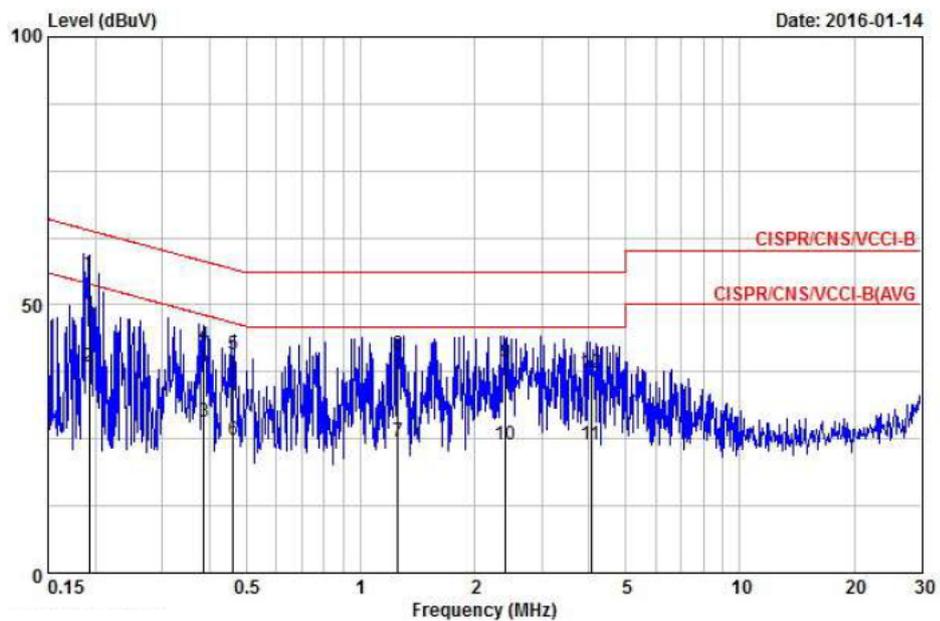
- a. AMN and ISN are 80 cm from the EUT and at least 80 cm from other units and other metal planes.
- b. EUT is connected to one artificial mains network (AMN).
- c. All other units of a system are powered from a second AMN. A multiple outlet strip can be used for multiple mains cords.
- d. Rear of EUT to be flushed with rear of table top.
- e. Peripherals shall be placed at a distance of 10 cm from each other and from the controller, except for the monitor which, if this is an acceptable installation practice, shall be placed directly on the top of the controller.
- f. If cables, which hang closer than 40 cm to the horizontal metal ground plane, cannot be shortened to appropriate length, the excess shall be folded back and forth forming a bundle 30 cm to 40 cm long.
- g. Mains cords and signal cables shall be positioned for their entire lengths, as far as possible, at 40 cm from the vertical reference plane.
- h. Cables of hand operated devices, such as keyboards, mice, etc. shall be placed as for normal usage.



5.4. Test Result of AC Powerline Conducted Emission

Test Mode	Mode 1	Test Site No.	CO01-NH
Test Frequency	0.15 MHz ~ 30 MHz	Test Engineer	Willy
Temperature	20°C	Relative Humidity	51%
Note: 1. Corrected Reading (dB $\mu$ V) = LISN Factor + Cable Loss + Read Level = Level			
2. All emissions not reported here are more than 10 dB below the prescribed limit.			
■ The test was passed at the minimum margin that marked by the frame in the following data			

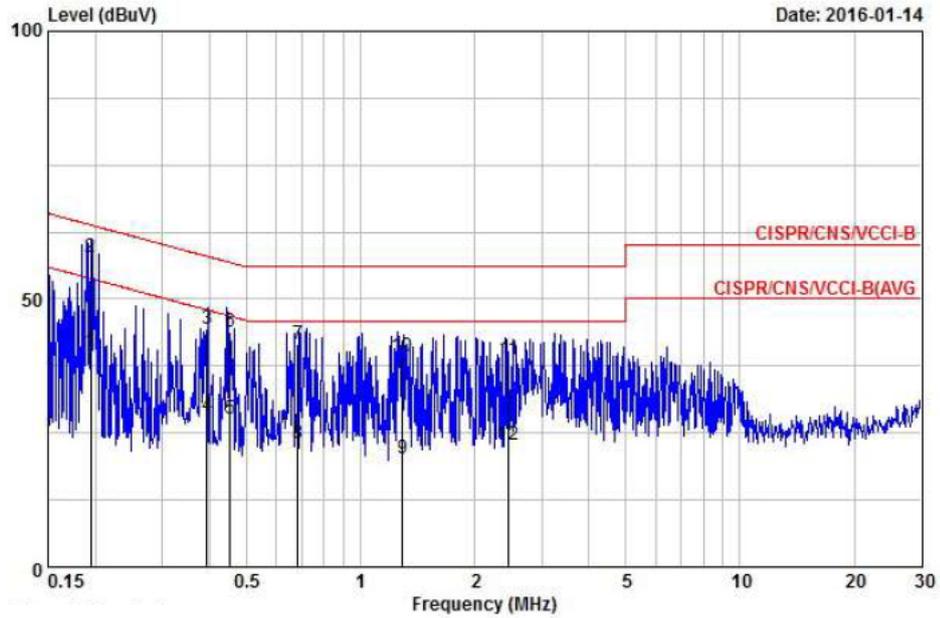
Line



	Freq	Level	Over Limit	Limit Line	Read Level	LISN Factor	Cable Loss	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.192	55.77	-8.16	63.93	45.62	10.05	0.10	QP
2	0.192	38.50	-15.43	53.93	28.35	10.05	0.10	AVERAGE
3	0.387	28.27	-19.85	48.12	18.13	10.04	0.10	AVERAGE
4	0.387	42.54	-15.58	58.12	32.40	10.04	0.10	QP
5	0.461	40.84	-15.83	56.67	30.70	10.04	0.10	QP
6	0.461	24.86	-21.81	46.67	14.72	10.04	0.10	AVERAGE
7	1.255	24.51	-21.49	46.00	14.35	10.06	0.10	AVERAGE
8	1.255	40.60	-15.40	56.00	30.44	10.06	0.10	QP
9	2.409	39.28	-16.72	56.00	29.07	10.08	0.13	QP
10	2.409	24.02	-21.98	46.00	13.81	10.08	0.13	AVERAGE
11	4.049	24.00	-22.00	46.00	13.69	10.11	0.20	AVERAGE
12	4.049	37.33	-18.67	56.00	27.02	10.11	0.20	QP



Neutral



	Freq	Level	Over Limit	Limit Line	Read Level	LISN Factor	Cable Loss	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.195	40.30	-13.53	53.83	29.72	10.48	0.10	AVERAGE
2	0.195	57.71	-6.12	63.83	47.13	10.48	0.10	QP
3	0.393	44.43	-13.56	57.99	33.85	10.48	0.10	QP
4	0.393	28.09	-19.90	47.99	17.51	10.48	0.10	AVERAGE
5	0.454	27.62	-19.18	46.81	17.04	10.48	0.10	AVERAGE
6	0.454	43.77	-13.03	56.81	33.19	10.48	0.10	QP
7	0.683	41.71	-14.29	56.00	31.13	10.48	0.10	QP
8	0.683	23.17	-22.83	46.00	12.59	10.48	0.10	AVERAGE
9	1.289	20.21	-25.79	46.00	9.62	10.49	0.10	AVERAGE
10	1.289	39.23	-16.77	56.00	28.64	10.49	0.10	QP
11	2.461	38.85	-17.15	56.00	28.21	10.51	0.13	QP
12	2.461	22.75	-23.25	46.00	12.11	10.51	0.13	AVERAGE



## **5.5. Test Result of Disturbance at Telecommunication Ports**

The EUT does not have the communication port.



## **6. Conducted Emissions Measurement\_For EN 55032**

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55032 Clause 6. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meter above the ground plane. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

### **6.1. Test Procedures**

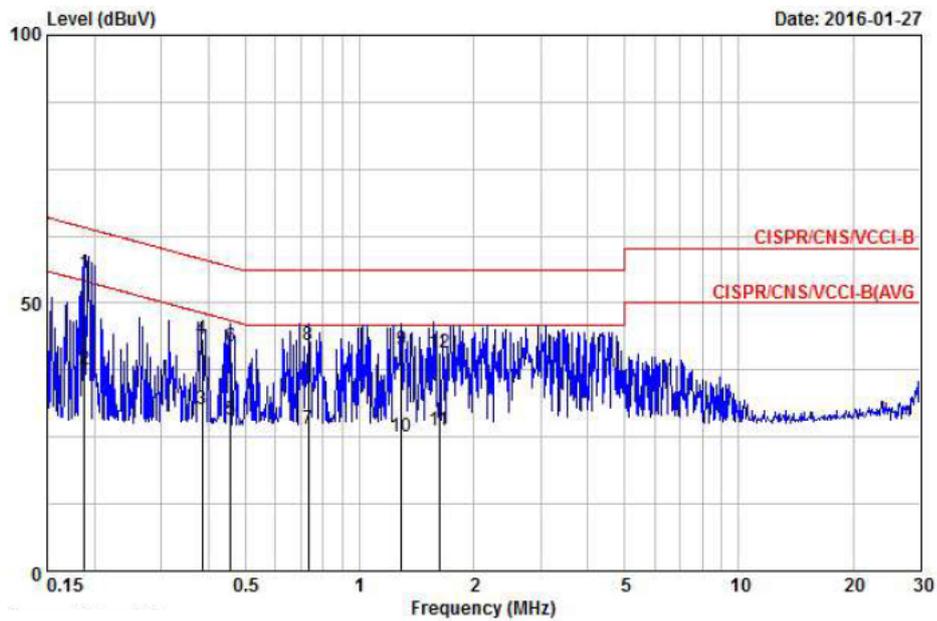
- a. The EUT was warmed up for 15 minutes before testing started.
- b. The EUT was placed on a desk 0.8 meter height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meter from any other grounded conducting surface.
- c. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- d. Connect Telecommunication port to ISN (Impedance Stabilization Network).
- e. All the support units are connect to the other LISN.
- f. The LISN provides 50 ohm, coupling impedance for the measuring instrument.
- g. The CISPR states that a 50 ohm, 50 microhenry LISN should be used.
- h. Both sides of AC line were checked for maximum conducted interference.
- i. The frequency range from 150 kHz to 30 MHz was searched.
- j. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- k. The EUT and local AE shall be arranged in the most compact practical arrangement within the test volume, while respecting typical spacing and the requirements defined in Annex D. The central point of the arrangement shall be positioned at the centre of the turntable. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



6.2. Test Result of AC Powerline Conducted Emission\_For EN 55032

Test Mode	Mode 1	Test Site No.	CO01-NH
Test Frequency	0.15 MHz ~ 30 MHz	Test Engineer	Willy
Temperature	18 °C	Relative Humidity	52 %
Note: 1. Corrected Reading (dB $\mu$ V) = LISN Factor + Cable Loss + Read Level = Level			
2. All emissions not reported here are more than 10 dB below the prescribed limit.			
■ The test was passed at the minimum margin that marked by the frame in the following data			

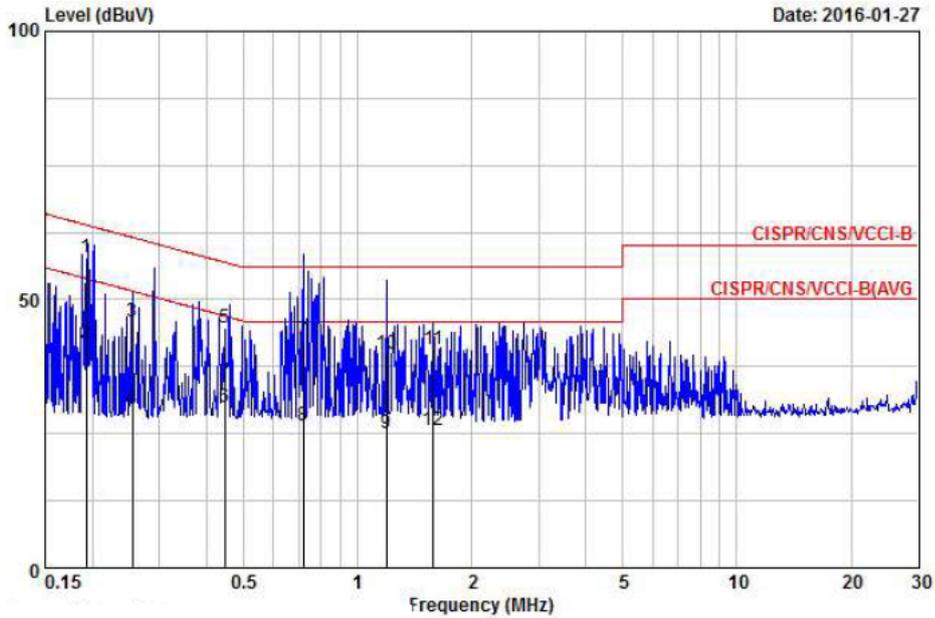
Line



	Freq	Level	Over	Limit	Read	LISN	Cable	Remark
	MHz	dBuV	Limit	Line	Level	Factor	Loss	
			dB	dBuV	dBuV	dB	dB	
1	0.188	55.62	-8.48	64.10	45.47	10.05	0.10	QP
2	0.188	37.58	-16.52	54.10	27.43	10.05	0.10	AVERAGE
3	0.385	30.26	-17.91	48.17	20.12	10.04	0.10	AVERAGE
4	0.385	43.21	-14.96	58.17	33.07	10.04	0.10	QP
5	0.456	28.18	-18.58	46.76	18.03	10.04	0.10	AVERAGE
6	0.456	41.87	-14.89	56.76	31.72	10.04	0.10	QP
7	0.731	26.51	-19.49	46.00	16.36	10.05	0.10	AVERAGE
8	0.731	42.30	-13.70	56.00	32.15	10.05	0.10	QP
9	1.289	41.25	-14.75	56.00	31.05	10.06	0.14	QP
10	1.289	25.17	-20.83	46.00	14.97	10.06	0.14	AVERAGE
11	1.619	26.12	-19.88	46.00	15.88	10.07	0.17	AVERAGE
12	1.619	40.86	-15.14	56.00	30.62	10.07	0.17	QP



Neutral



	Freq	Level	Over	Limit	Read	LISN	Cable	Loss	Remark
	MHz	dBuV	Limit	Line	Level	Factor	Loss	dB	
			dB	dBuV	dBuV	dB			
1	0.192	57.97	-5.96	63.93	47.39	10.48	0.10	QP	
2	0.192	41.85	-12.08	53.93	31.27	10.48	0.10	AVERAGE	
3	0.255	45.79	-15.81	61.60	35.21	10.48	0.10	QP	
4	0.255	29.62	-21.98	51.60	19.04	10.48	0.10	AVERAGE	
5	0.447	44.61	-12.32	56.93	34.03	10.48	0.10	QP	
6	0.447	29.97	-16.96	46.93	19.39	10.48	0.10	AVERAGE	
7	0.720	42.47	-13.53	56.00	31.89	10.48	0.10	QP	
8	0.720	26.53	-19.47	46.00	15.95	10.48	0.10	AVERAGE	
9	1.191	24.95	-21.05	46.00	14.34	10.49	0.12	AVERAGE	
10	1.191	39.89	-16.11	56.00	29.28	10.49	0.12	QP	
11	1.585	40.73	-15.27	56.00	30.07	10.49	0.17	QP	
12	1.585	25.64	-20.36	46.00	14.98	10.49	0.17	AVERAGE	



### **6.3. Test Result of Disturbance at Telecommunication Ports**

The EUT does not have the communication port.



## **7. Radiated Emission Measurement\_For EN 55022**

Radiated emissions from 30 MHz to 1,000 MHz were measured with a bandwidth of 120 kHz for 30 MHz to 1,000 MHz and 1 MHz for above 1GHz according to the methods defines in European Standard EN 55022, Clause 10. The EUT was placed on a nonmetallic stand, 0.8 meter above the ground plane. The interface cables and equipment positions were varied within limits of reasonable applications to determine the positions producing maximum radiated emissions.

### **7.1. Test Procedures**

#### **For Below 1GHz**

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 10 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.



**For above 1GHz**

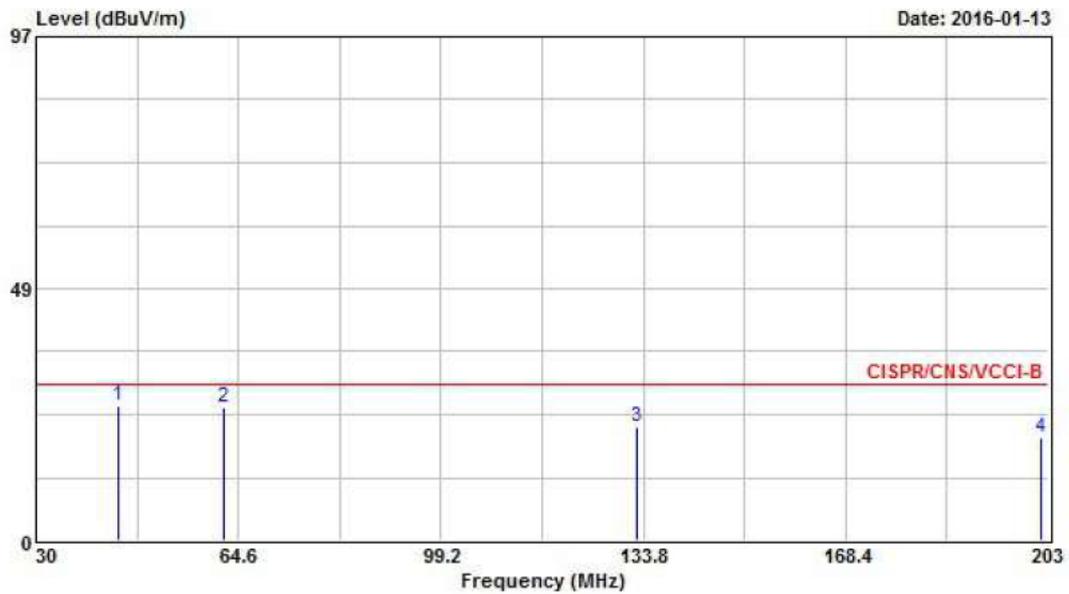
- a. Same test set up as below 1GHz radiated testing.
- b. The EUT was set 3 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
- c. There should be absorber placed between the EUT and Antenna and its located size should let the test site meet CISPR16-1-4 requirement.
- d. The table was rotated 360 degrees to determine the position of the highest radiation.
- e. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- f. Set the DRG Horn Antenna at 1M height, then run the turn table to get the maximum noise reading from Horizontal and Vertical polarity separately.
- g. When EUT locating on the turn-table, and its height is over 172cm (Antenna's 3dB beam width of 6GHz is  $27^\circ$  ), the DRG Horn Antenna must be raised up and descended down, then turning around the turn-table to get the maximum noise reading of the Horizontal and Vertical polarity separately. Note the maximum raise up height is same as the top of EUT.
- h. If emission level of the EUT in peak mode was 20dB lower than average limit (that means the emission level in peak mode also complies with the limit in average mode), then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions will be measured in average mode again and reported.



**7.2. Test Result of Radiated Emission for Below 1GHz\_For EN 55022**

Test mode	Mode 1	Test Site No.	OS03-NH
Test frequency	30 MHz ~ 1000 MHz	Test Engineer	Alan
Temperature	20°C	Relative Humidity	53%
Note: 1. Emission level (dB $\mu$ V/m) = 20 log Emission level ( $\mu$ V/m)			
2. Corrected Reading : Antenna Factor + Cable Loss + Read Level – Preamp Factor = Level			
■ The test was passed at the minimum margin that marked by the frame in the following data			

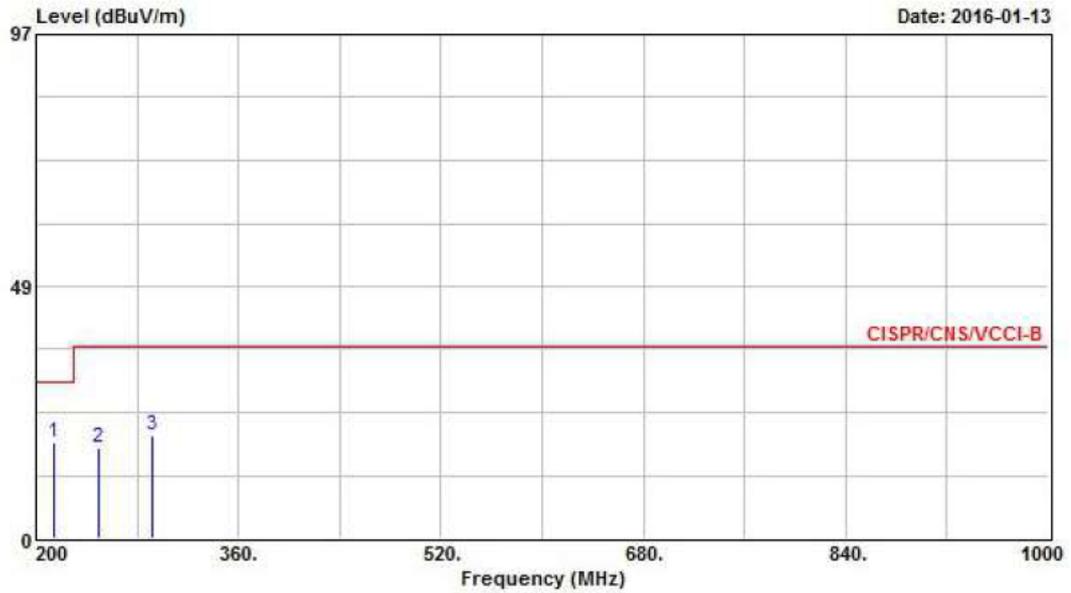
**Vertical**



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	44.000	25.85	-4.15	30.00	42.57	10.64	1.06	28.42	QP	100	316
2	62.000	25.68	-4.32	30.00	46.40	6.39	1.27	28.38	Peak	---	---
3	132.600	21.80	-8.20	30.00	36.00	11.97	2.00	28.17	Peak	---	---
4	201.720	19.69	-10.31	30.00	35.42	9.55	2.65	27.93	Peak	---	---



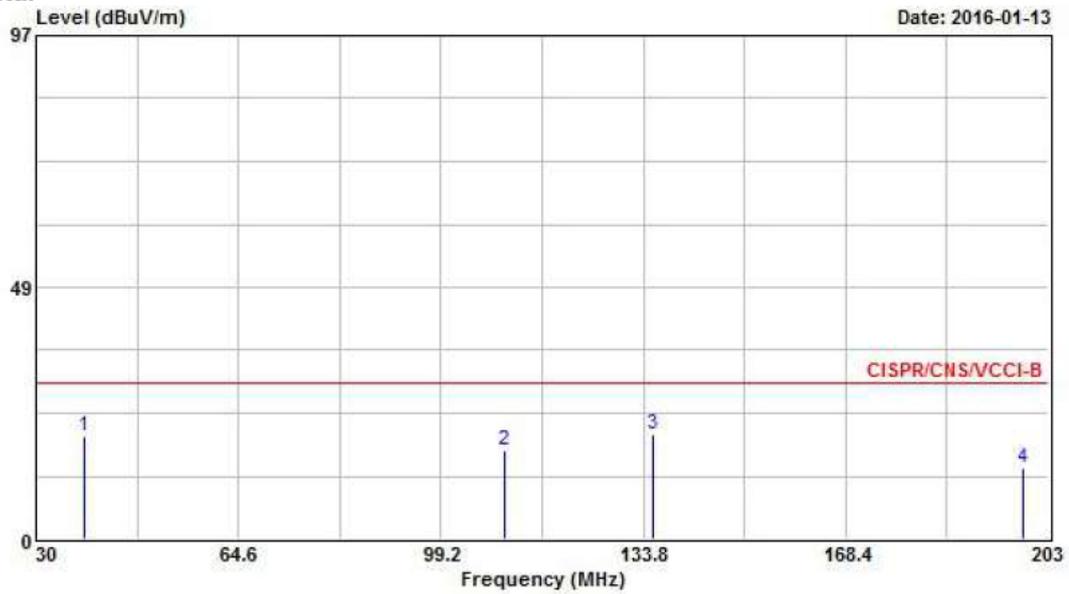
**Vertical**



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	214.140	18.36	-11.64	30.00	33.22	10.30	2.75	27.91	Peak	---	---
2	249.510	17.30	-19.70	37.00	29.65	12.39	3.11	27.85	Peak	---	---
3	292.440	19.86	-17.14	37.00	30.99	13.17	3.48	27.78	Peak	---	---



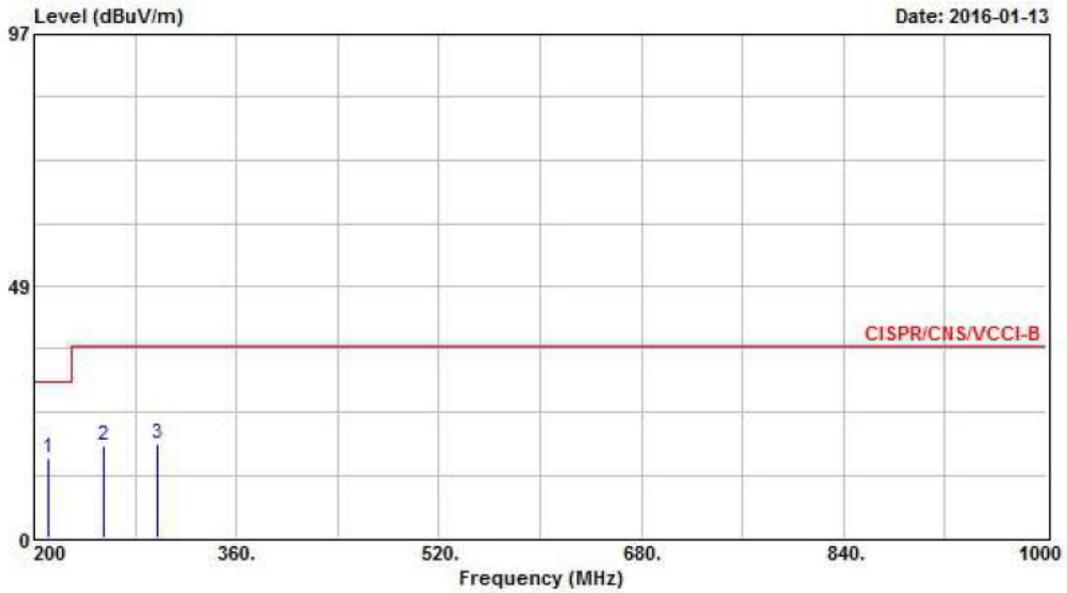
**Horizontal**



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	38.100	19.72	-10.28	30.00	33.37	13.81	0.97	28.43	Peak	---	---
2	110.190	16.97	-13.03	30.00	31.40	12.01	1.81	28.25	Peak	---	---
3	135.300	20.21	-9.79	30.00	34.60	11.74	2.03	28.16	Peak	---	---
4	198.750	13.52	-16.48	30.00	29.40	9.43	2.62	27.93	Peak	---	---



Horizontal



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	211.170	15.34	-14.66	30.00	30.39	10.13	2.73	27.91	Peak	---	---
2	254.640	17.65	-19.35	37.00	29.80	12.53	3.16	27.84	Peak	---	---
3	297.570	18.00	-19.00	37.00	29.00	13.25	3.52	27.77	Peak	---	---



### **7.3. Test Result of Radiated Emission for Above 1GHz\_For EN 55022**

The highest frequency of the internal sources of the EUT is less than 10 MHz, so the measurement shall only be made up to 1GHz.



## 8. Radiated Emission Measurement\_For EN 55032

Radiated emissions from 30 MHz to 6,000 MHz were measured with a bandwidth of 120 kHz for 30 MHz to 1,000 MHz and 1 MHz for above 1GHz according to the methods defines in European Standard EN 55032, Clause 6. The EUT was placed on a nonmetallic stand, 0.8 meter above the ground plane. The interface cables and equipment positions were varied within limits of reasonable applications to determine the positions producing maximum radiated emissions.

### 8.1. Test Procedures

#### For Below 1GHz

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
  - b. The EUT was set 3 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
  - c. The table was rotated 360 degrees to determine the position of the highest radiation.
  - d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
  - e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
  - f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
  - g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.
- H The EUT and local AE shall be arranged in the most compact practical arrangement within the test volume, while respecting typical spacing and the requirements defined in Annex D. The central point of the arrangement shall be positioned at the centre of the turntable. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



**For above 1GHz**

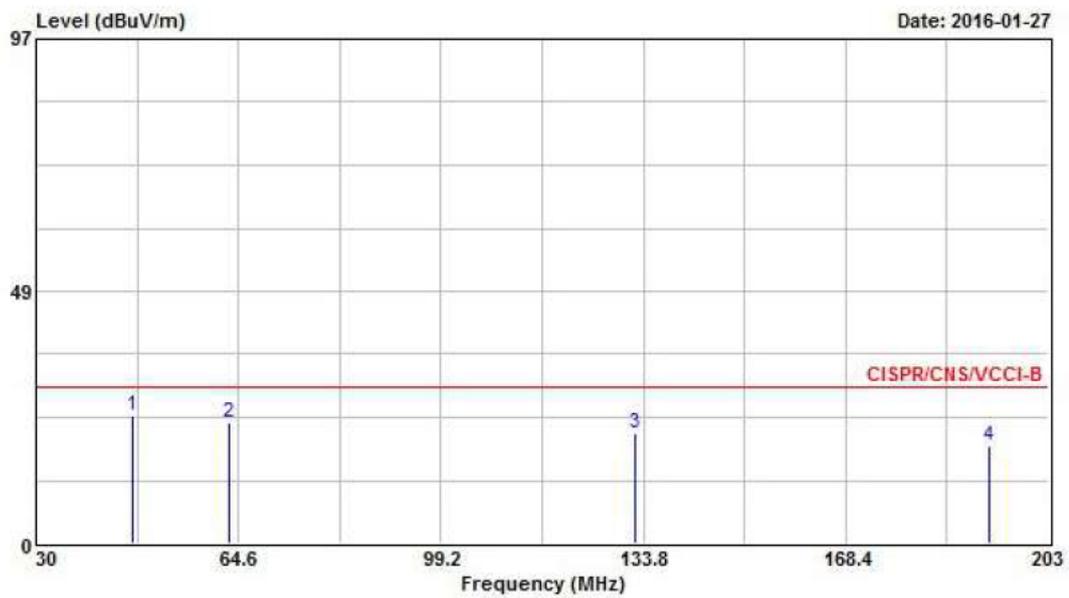
- a. Same test set up as below 1GHz radiated testing.
- b. The EUT was set 3 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
- c. There should be absorber placed between the EUT and Antenna and its located size should let the test site meet CISPR16-1-4 requirement.
- d. The table was rotated 360 degrees to determine the position of the highest radiation.
- e. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- f. Set the DRG Horn Antenna at 1M height, then run the turn table to get the maximum noise reading from Horizontal and Vertical polarity separately.
- g. When EUT locating on the turn-table, and its height is over 172cm (Antenna's 3dB beam width of 6GHz is  $27^\circ$  ), the DRG Horn Antenna must be raised up and descended down, then turning around the turn-table to get the maximum noise reading of the Horizontal and Vertical polarity separately. Note the maximum raise up height is same as the top of EUT.
- h. If emission level of the EUT in peak mode was 20dB lower than average limit (that means the emission level in peak mode also complies with the limit in average mode), then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions will be measured in average mode again and reported.
- i. The EUT and local AE shall be arranged in the most compact practical arrangement within the test volume, while respecting typical spacing and the requirements defined in Annex D. The central point of the arrangement shall be positioned at the centre of the turntable. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



**8.2. Test Result of Radiated Emission for Below 1GHz\_For EN 55032**

Test mode	Mode 1	Test Site No.	OS03-NH
Test frequency	30 MHz ~ 1000 MHz	Test Engineer	Alan
Temperature	16 °C	Relative Humidity	54 %
Note: 1. Emission level (dB $\mu$ V/m) = 20 log Emission level ( $\mu$ V/m)			
2. Corrected Reading : Antenna Factor + Cable Loss + Read Level – Preamp Factor = Level			
■ The test was passed at the minimum margin that marked by the frame in the following data			

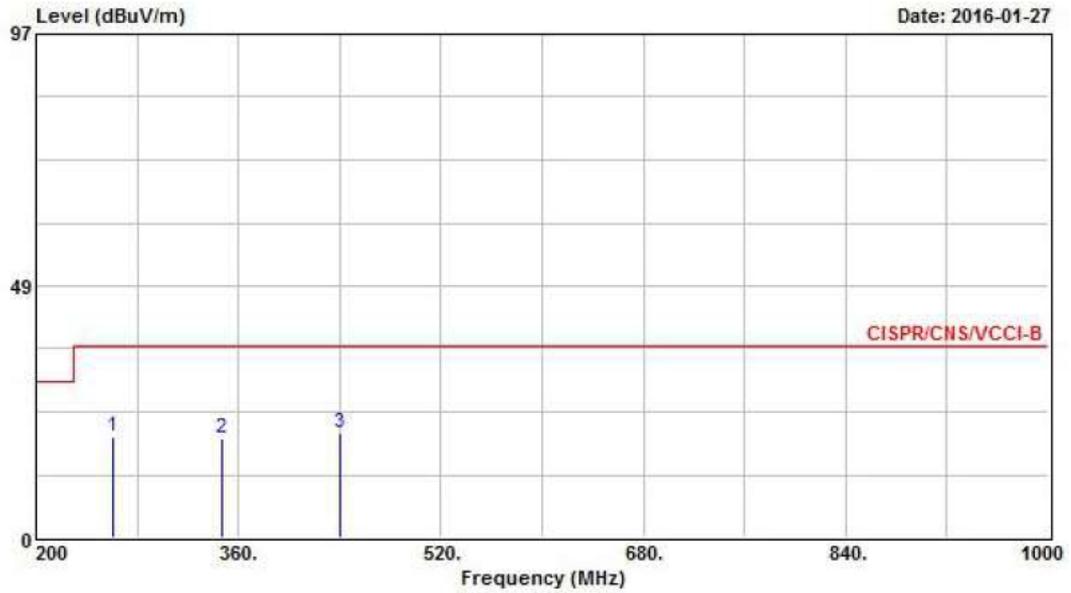
**Vertical**



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	46.400	24.60	-5.40	30.00	42.45	9.48	1.09	28.42	QP	100	345
2	63.000	23.35	-6.65	30.00	44.04	6.41	1.28	28.38	Peak	---	---
3	132.420	21.10	-8.90	30.00	35.30	11.97	2.00	28.17	Peak	---	---
4	192.970	18.65	-11.35	30.00	34.60	9.43	2.57	27.95	Peak	---	---



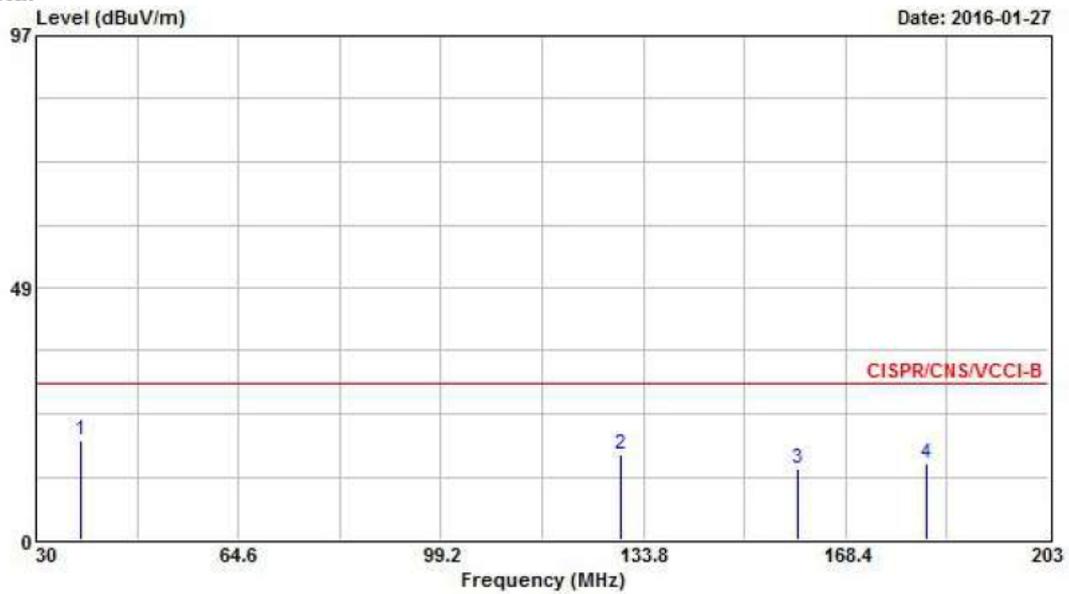
**Vertical**



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	260.800	19.61	-17.39	37.00	31.60	12.63	3.21	27.83	Peak	---	---
2	347.200	19.06	-17.94	37.00	29.00	14.44	3.74	28.12	Peak	---	---
3	440.000	20.25	-16.75	37.00	28.41	16.43	4.13	28.72	Peak	---	---



Horizontal



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	37.610	19.03	-10.97	30.00	32.68	13.81	0.97	28.43	Peak	---	---
2	129.990	16.36	-13.64	30.00	30.37	12.20	1.97	28.18	Peak	---	---
3	160.270	13.65	-16.35	30.00	29.39	10.08	2.25	28.07	Peak	---	---
4	182.240	14.69	-15.31	30.00	30.80	9.43	2.45	27.99	Peak	---	---



**Horizontal**

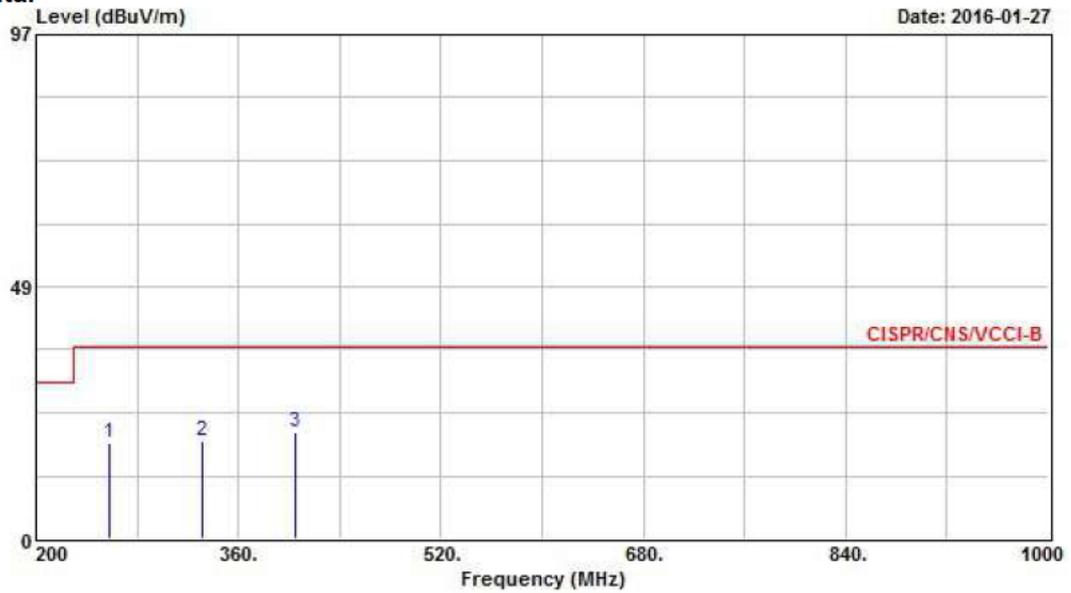


Table 1: Peak Data

	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	257.600	18.53	-18.47	37.00	30.61	12.58	3.18	27.84	Peak	---	---
2	331.200	18.75	-18.25	37.00	29.00	14.06	3.69	28.00	Peak	---	---
3	404.800	20.49	-16.51	37.00	29.21	15.81	4.00	28.53	Peak	---	---



### **8.3. Test Result of Radiated Emission for Above 1GHz**

The highest frequency of the internal sources of the EUT is less than 10 MHz, so the measurement shall only be made up to 1GHz.

## 9. Harmonic Current Emissions Measurement

### 9.1. Standard

- Standard : EN 61000-3-2

### 9.2. Test Procedure

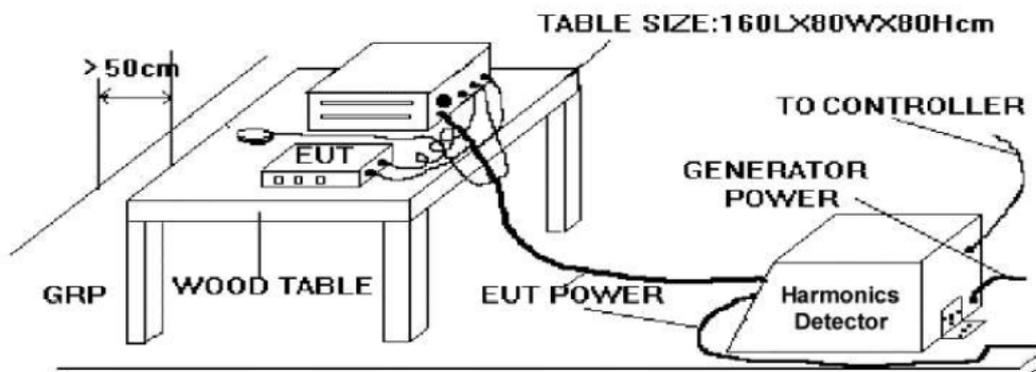
The measurement of harmonic currents shall be performed as follows:

- for each harmonic order, measure the 1.5 s smoothed r.m.s. harmonic current in each DFT time window as defined in EN / IEC 61000-4-7: 2002.
- calculate the arithmetic average of the measured values from the DFT time windows, over the entire observation period Short cyclic ( $T_{\text{cycle}} \leq 2.5$  min). Because of synchronisation to meet the requirements for repeatability in 5%.

### 9.3. Test Equipment Settings

Harmonic Parameters	Setting
Line Voltage	230 V
Line Frequency	50 Hz
Device Class	---
Current Measurement Range	High
Measurement Delay	10.0 seconds
Test Duration	10.0 minutes
Class determination Pre-test Duration	10.0 seconds

### 9.4. Typical Test Setup Layout of Harmonic Current Emissions





**9.5. Test Result of Harmonic Current Emissions**

V_RMS (Volts):	230.07	Frequency(Hz):	49.99
I_Peak (Amps):	1.021	I_RMS (Amps):	0.257
I_Fund (Amps):	0.131	Crest Factor:	3.993
Power (Watts):	29.3	Power Factor:	0.502

As specified on clause 7 of EN 61000-3-2, the limits are not specified for equipment with a rated power of 75W or less.

## 10. Voltage Fluctuations and Flicker Measurement

### 10.1. Standard

- Product Standard : EN 61000-3-3

### 10.2. Test Procedure

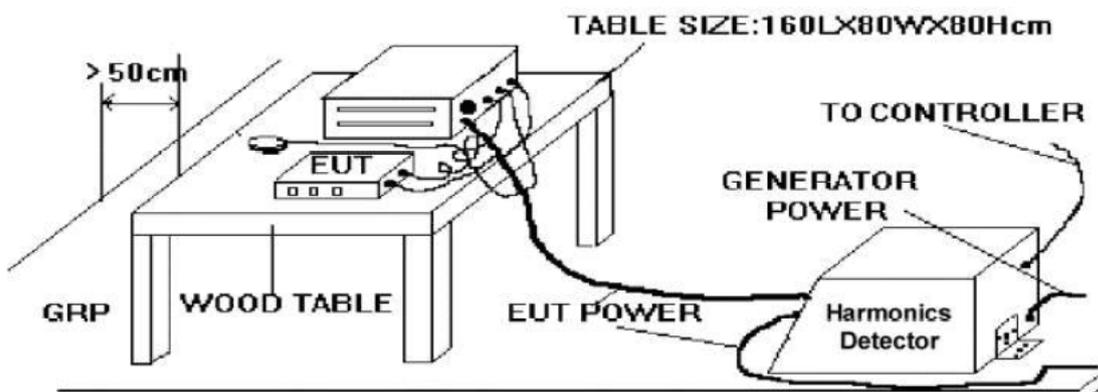
The equipment shall be tested under the conditions of **Clause 5**.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of  $\pm 8\%$  is achieved during the whole assessment procedure.

### 10.3. Test Equipment Settings

Flicker Parameters	Setting
Line Voltage	230 V
Line Frequency	50 Hz
Measurement Delay	10.0 seconds
Pst Integration Time	10.0 minutes
Pst Integration Periods	1
Test Duration	10.0 minutes

### 10.4. Typical Test Setup Layout of Voltage Fluctuations and Flicker





**10.5. Test Result of Voltage Fluctuation and Flicker**

<b>Test mode</b>	Mode 1
<b>Final Test Result</b>	<b>PASS</b>
<b>Temperature</b>	22°C
<b>Relative Humidity</b>	50%
<b>Atmospheric Pressure</b>	101 kPa
<b>Test Date</b>	Jan. 20, 2016
<b>Test Engineer</b>	Mark

Parameter values recorded during the test:

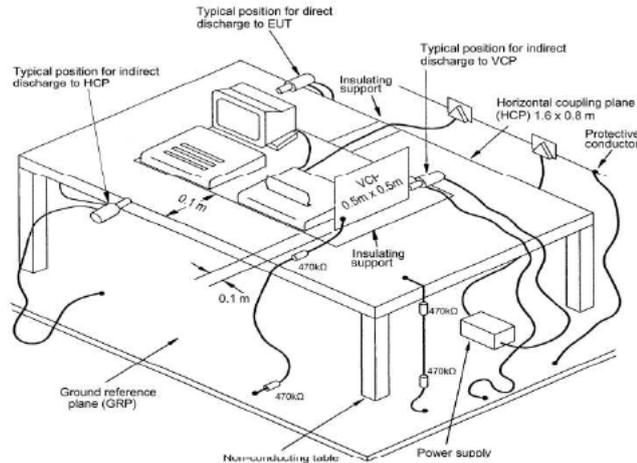
Vrms at the end of test (Volt): 229.73

Highest dt (%)	0.30	Test limit (%)	3.30	Pass
T-max (mS)	0	Test limit (mS)	500.0	Pass
Highest dc (%)	0.00	Test limit (%)	3.30	Pass
Highest dmax (%)	0.19	Test limit (%)	4.00	Pass
Highest Pst (10 min. period)	0.064	Test limit	1.000	Pass

**11. Electrostatic Discharge Immunity Measurement (ESD)**

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b> $\pm 2 / \pm 4$ kV for contact discharge
Required Performance Criteria	<b>B</b> $\pm 2 / \pm 4$ kV for contact discharge
Basic Standard	IEC 61000-4-2
Product Standard	EN 55024:2010
Level	2 for contact discharge
Test Voltage	$\pm 2 / \pm 4$ kV for contact discharge
Discharge Impedance	330 ohm / 150 pF
Temperature	21 °C
Relative Humidity	49 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 21, 2016
Test Engineer	Mark
Observation	The test points, please refer to section 9.5.
Observation	The EUT has no slots, apertures, or insulating surfaces. So, the air discharge test is not applicable.

### 11.1. Test Setup



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- b. AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

### 11.2. Test Setup for Tests Performed in Laboratory

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the SPORTON EMC LAB., we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1 m minimum was provided between the EUT and the wall of the Lab., and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2 m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resistor located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8 m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m x 0.5 m.

### 11.3. ESD Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
  - ambient temperature: 15 °C to 35 °C;
  - relative humidity : 30 % to 60 %;
  - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On preselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
  - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
  - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
  - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.



### 11.4. Test Severity Levels

#### 9.4.1. Contact Discharge

Level	Test Voltage (kV) of Contact discharge
1	±2
2	±4
3	±6
4	±8
X	Specified

Remark : "X" is an open level.

#### 9.4.2. Air Discharge

Level	Test Voltage (kV) of Air Discharge
1	±2
2	±4
3	±8
4	±15
X	Specified

Remark : "X" is an open level.



**11.5. Test Points**

**11.5.1. Test Result of Air Discharge**

Because the sample can't discharge by itself, we determine the status is pass.

**11.5.2. Test Result of Contact Discharge**

**Direct discharge**

No Direct discharge

***Indirect discharge to HCP and VCP***

Test Point	No. of Discharges	Contact Discharge/Pointed Tip				Test Record
		+2kV	-2kV	+4kV	-4kV	
HCP (At Front)	25	A	A	A	A	Normal
HCP (At Left)	25	A	A	A	A	Normal
HCP (At Right)	25	A	A	A	A	Normal
HCP (At Rear)	25	A	A	A	A	Normal
VCP (At Front)	25	A	A	A	A	Normal
VCP (At Left)	25	A	A	A	A	Normal
VCP (At Right)	25	A	A	A	A	Normal
VCP (At Rear)	25	A	A	A	A	Normal

## 12. Radio Frequency Electromagnetic Field Immunity Measurement (RS)

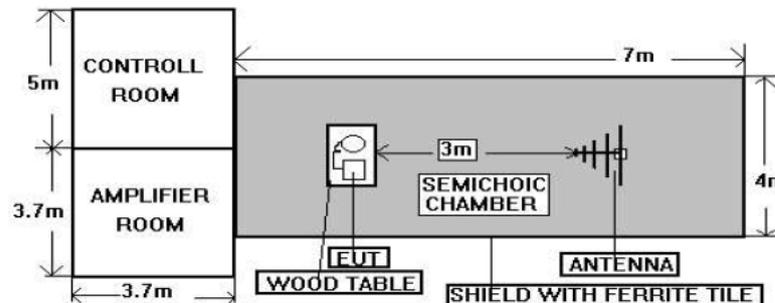
Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b>
Required Performance Criteria	<b>A</b>
Basic Standard	IEC 61000-4-3
Product Standard	EN 55024:2010
Level	2
Frequency Range	80-1000 MHz
Field Strength	3 V/m (unmodulated, r.m.s) 80% AM (1 kHz)
Temperature	22 °C
Relative Humidity	47 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 20, 2016
Test Engineer	Mark

### 12.1. Test Record

Frequency Band: 80-1000 MHz

Sides of the EUT have been exposed to the field	Antenna positioned	Test field strength Level	Test field strength (V/m)	Test Record
Front	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Left	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Back	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Right	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)

## 12.2. Test Setup



**NOTE :** The SPORTON 7m x 4m x 4m semi-anechoic chamber is compliance with the sixteen point's uniform field requirement as stated in IEC 61000-4-3 Section 6.2.

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

## 12.3. Test Procedure

- The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- The bilog antenna which is enabling the complete frequency range of 80-1000MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- The test is normally performed with the generating antenna facing each of four sides of the EUT. The polarization of the field generated by the broadband (bilog) antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- At each of the above conditions, the frequency range is swept 80-1000MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of  $1.5 \times 10^{-3}$  decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.



**12.4. Test Severity Levels**

Frequency Band : 80-1000MHz

Level	Test field strength (V/m)
1	1
2	3
3	10
X	Specified
Remark : "X" is an open class.	

### 13. Electrical Fast Transient/Burst Immunity Measurement (EFT/BURST)

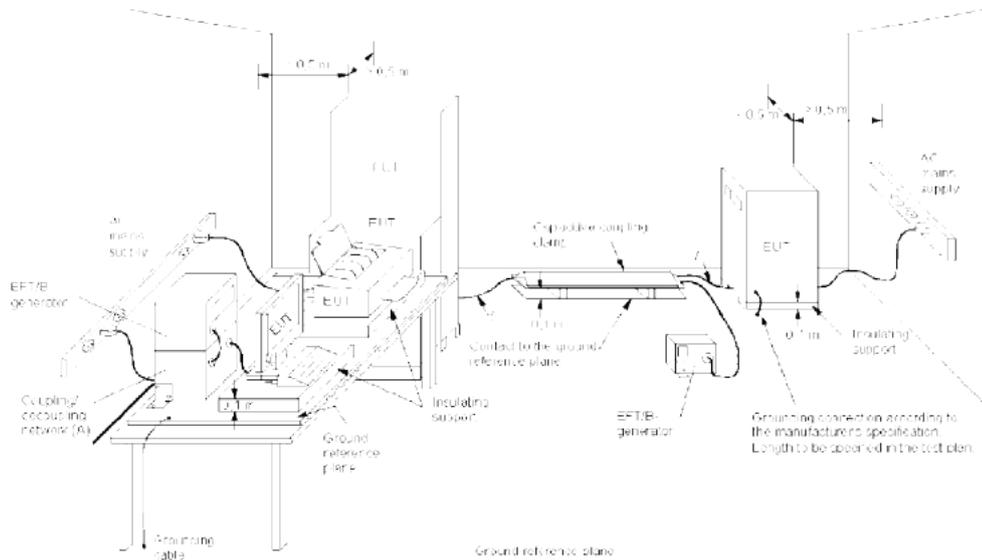
Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b>
Required Performance Criteria	<b>B</b>
Basic Standard	IEC 61000-4-4
Product Standard	EN 55024:2010
Level	on input power ports – 2
Test Voltage	on input power ports -- $\pm 0.5 / \pm 1.0$ kV
Impulse wave shape	5/50 ns (Tr/Th)
Impulse frequency	5 kHz
Test Repetition Rate	1 time / minute
Temperature	22 °C
Relative Humidity	50 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 20, 2016
Test Engineer	Mark
Observation	Normal

#### 13.1. Test Record

■ on Input power ports:

Test Location	Polarity	Test Level	Voltage (Peak)	Test Record
L+N	+	2	0.5 / 1.0 kV	Normal (No influencing)
	-	2	0.5 / 1.0 kV	Normal (No influencing)

**13.2. Test setup**



**Key**

- f length between clamp and the EUT to be tested (should be 0.5 m ± 0.05 m)
- (A) location for supply line coupling
- (B) location for signal lines coupling

REC: 901/04

The EUT was placed on a ground reference plane and was insulated from it by an insulating support about 0.1 m thick. If the EUT is table-top equipment, it was located approximately 0.8 m above the GRP. Was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. It shall project beyond the EUT by at least 0.1 m on all sides and connected to the protective earth. In the SPORTON EMC LAB., We provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system. The EUT was arranged and connected according to its functional requirements. The minimum distance between the EUT and other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. using the coupling clamp, the minimum distance between the coupling plates and all other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. The length of the signal and power lines between the coupling device and the EUT was 0.5 m or less.



### **13.3. Test on Power Line**

- a. The EFT/B-generator was located on the GRP. The length from the EFT/B-generator to the EUT as not exceeds 0.5 m.
- b. The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.

### **13.4. Test on Communication Lines**

- a. The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
- b. The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.

### **13.5. Test Procedure**

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
  - ambient temperature: 15 °C to 35 °C;
  - relative humidity : 45 % to 75 %;
  - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria :
  - Normal performance within the specification limits.
  - Temporary degradation or loss of function or performance which is self-recoverable.
  - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
  - Degradation or loss of function which is not recoverable due to damage of equipment (components).

### 13.6. Test Severity Levels

The following test severity levels are recommended for the fast transient/burst test :

Open circuit output test voltage $\pm 10\%$		
Level	On Input power ports	On signal port and telecommunication ports
1	0.5 kV	0.25 kV
2	1.0 kV	0.50 kV
3	2.0 kV	1.00 kV
4	4.0 kV	2.00 kV
X	Specified	Specified

Remark : " X " is an open level.  
 The level is subject to negotiation between the user and the manufacturer or is specified by the manufacturer.

## 14. Surge Immunity Measurement

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b> for input power port
Required Performance Criteria	<b>B</b> for input power ports
Basic Standard	IEC 61000-4-5
Product Standard	EN 55024:2010
Surge wave form (Tr/Th)	1,2/50 ( 8/20 ) $\mu$ s for input power ports
Level	on input power ports – 3
Test Voltage	on Input Power Port -- $\pm 1.0 / \pm 2.0$ kV
Phase Angle	0°, 90°, 180°, 270°
Number of surges	5 positive and 5 negative pulses
Pulse Repetition Rate	1 time / min. (maximum)
Temperature	22 °C
Relative Humidity	50 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 20, 2016
Test Engineer	Mark
Observation	Please refer to section 12.1

### 14.1. Test Record

■ on Input power ports:

Test Location	Voltage (kV)	Polarity	Phase Angle				Test Record
			0°	90°	180°	270°	
L - N	1.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)
L - PE	2.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)
N - PE	2.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)

Remark : PE = Earth reference

## 14.2. Test Severity Levels

Level	Open-circuit test voltage, $\pm 10\%$ , kV
1	0.5
2	1.0
3	2.0
4	4.0
x	Specified
Remark : " X " is an open level. This level can be specified in the product specification.	

## 14.3. Test Procedure

- a. Climatic conditions
 

The climatic conditions shall comply with the following requirements :

  - ambient temperature : 15 °C to 35 °C
  - relative humidity : 10 % to 75 %
  - atmospheric pressure : 86 kPa to 106 kPa ( 860 mbar to 1060 mbar ).
- b. Electromagnetic conditions
 

The electromagnetic environment of the laboratory shall not influence the test results.
- c. The test shall be performed according the test plan that shall specify the test set-up with
  - generator and other equipment utilized;
  - test level ( voltage/current );
  - generator source impedance;
  - internal or external generator trigger;
  - number of tests : at least five positive and five negative at the selected points;
  - repetition rate : maximum 1/min.
  - inputs and outputs to be tested;
  - representative operating conditions of the EUT;
  - sequence of application of the surge to the circuit;
  - phase angle in the case of a.c. power supply;
  - actual installation conditions, for example :
    - AC : neutral earthed,
    - DC : ( + ) or ( - ) earthed to simulated the actual earthing conditions.
- d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave ( positive and negative ).
- e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level



specified in the product standard or test plan.

- g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level ( let-through level ) of the primary protection.
- h. If the actual operating signal sources are not available, they may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according to the test plan.
- i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test previously unstressed equipment shall be used and protection devices shall be replaced.

#### **14.4. Operating Condition**

Full system

## 15. Conducted Disturbances Induced by Radio-Frequency Field Immunity Measurement (CS)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b>
Required Performance Criteria	<b>A</b>
Basic Standard	IEC 61000-4-6
Product Standard	EN 55024:2010
Level	2
Test Voltage	3 V (unmodulated, r.m.s), 80% AM (1 kHz)
Frequency Range	0.15 MHz to 80 MHz
Test Port	on Input Power Port
Dwell time	2.9 seconds
Frequency step size	1 %
Coupling mode	CDN M016 M2 for AC power port
Temperature	21 °C
Relative Humidity	48 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 20, 2016
Test Engineer	Mark

### 15.1. Test Record

Test Port	Test field strength level	Test field strength (V rms)	Test Record
Input power port	2	3	Normal (No influencing)

## 15.2. Test Severity Levels

Level	Voltage Level (EMF)
1	1 V rms
2	3 V rms
3	10 V rms
x	Specified
Remark : " X " is an open level. This level can be specified in the product specification.	

## 15.3. Operating Condition

Full system

## 15.4. Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- g. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- h. The use of special exercising programs is recommended.
- i. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- j. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

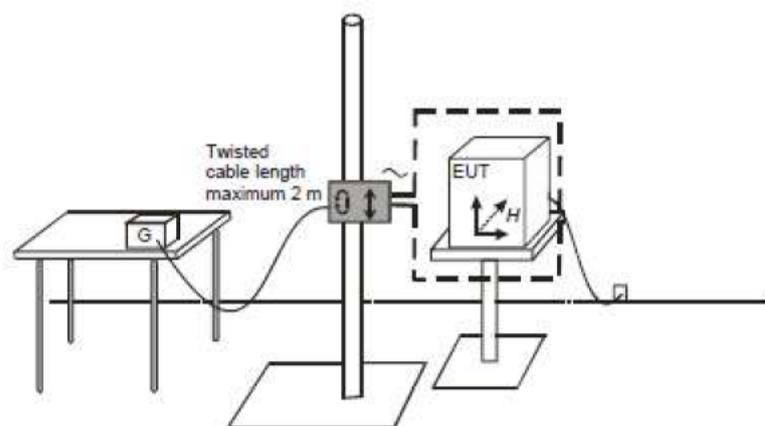
## 16. Power Frequency Magnetic Field immunity Measurement (PFMF)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b>
Required Performance Criteria	<b>A</b>
Basic Standard	IEC 61000-4-8
Product Standard	EN 55024:2010
Temperature	22 °C
Relative Humidity	50 %
Atmospheric Pressure	101kPa
Test Date	Jan. 21, 2016
Test Engineer	Mark
Observation	Please refer to section 14.1

### 16.1. Test Record

Power Frequency Magnetic Field	Testing duration	Coil Orientation	Test Record
50/60Hz, 1A/m	1.0 Min	X-axis	Normal (No influencing)
50/60Hz, 1A/m	1.0 Min	Y-axis	Normal (No influencing)
50/60Hz, 1A/m	1.0 Min	Z-axis	Normal (No influencing)

### 16.2. Test Setup



EUT : Equipment under test    G : Test Generator

## 17. Voltage Dips and Voltage Interruptions Immunity Measurement (DIP)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	C for voltage interruption, A/A for voltage dips
Required Performance Criteria	C for voltage interruption, C/B for voltage dips
Basic Standard	IEC 61000-4-11
Product Standard	EN 55024:2010
Test Port	Input power ports
Temperature	22 °C
Relative Humidity	50 %
Atmospheric Pressure	101 kPa
Test Date	Jan. 21, 2016
Test Engineer	Mark
Observation	Please refer to section 15.1 and 15.2

### 17.1. Test Record of Voltage Interruption

Voltage (V)	Performance Criterion (Phase Angle)		Reduction Voltage	Duration (Periods)
	0°	180°		
100/240	C	C	>95 %	250
Observation	After the interruption, the power of EUT reset automatically.			

### 17.2. Test Record of Voltage Dips

Voltage (V)	Performance Criterion (Phase Angle)		Reduction Voltage	Duration (Periods)
	0°	180°		
100/240	A	A	30 %	25
100/240	A	A	>95 %	0.5



### **17.3. Testing Requirement and Procedure**

The test was based on IEC 61000-4-11

### **17.4. Test Conditions**

- a. Source voltage and frequency : 100/240V, 50Hz, Single phase.
- b. Test of interval : 10 sec.
- c. Level and duration : Sequency of 3 dips/interrupts.
- d. Voltage rise (and fall) time : 1 ~ 5  $\mu$ s.

### **17.5. Operating Condition**

Full system



## 18. List of Measuring Equipment Used

EN 55022

### < Conducted Emission >

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Receiver	R&S	ESCS 30	100357	9 kHz - 2.75 GHz	Jan. 21, 2015	Conduction (CO01-NH)
LISN	SCHAFFNER	NNB41	06/10024	9kHz - 30MHz	Dec. 14, 2015	Conduction (CO01-NH)
Power Filter	CORCOM	MR12030	N/A	30A*2	NCR	Conduction (CO01-NH)
RF Cable-CON	Suhner Switzerland	RG223/U	CB004	9kHz - 30MHz	Dec. 10, 2015	Conduction (CO01-NH)

Note: Calibration Interval of instruments listed above is one year. NCR: No Calibration Request.

### < Radiated Emission below 1GHz >

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Open Area Test Site	SPORTON	OATS-10	OS03-NH	30 MHz - 1 GHz 10m, 3m	Oct. 03, 2015	Radiation (OS03-NH)
Amplifier	HP	8447D	2944A08292	0.1 MHz - 1.3 GHz	May. 11, 2015	Radiation (OS03-NH)
Spectrum Analyzer	Advantest	R3261C	81720147	9 kHz - 2.6 GHz	Nov. 09, 2015	Radiation (OS03-NH)
Receiver	R&S	ESCS 30	838251/002	9 kHz - 2.75 GHz	Nov. 20, 2015	Radiation (OS03-NH)
Bilog Antenna	CHASE	CBL6112D	25234	30 MHz - 2 GHz	Feb. 28, 2015	Radiation (OS03-NH)
Turn Table	EMCO	2080	9805-2065	0 - 360 degree	NCR	Radiation (OS03-NH)
Antenna Mast	EMCO	2075	9804-2151	1 m - 4 m	NCR	Radiation (OS03-NH)
RF Cable-R10m	HSCN	RG213U	2X11N	30 MHz - 1 GHz	Aug. 05, 2015	Radiation (OS03-NH)

Note: Calibration Interval of instruments listed above is one year. NCR: No Calibration Request.

**EN 55032****< Conducted Emission >**

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Receiver	R&S	ESCS 30	100167	9 kHz - 2.75 GHz	Nov. 12, 2015	Conduction (CO01-NH)
LISN	SCHAFFNER	NNB41	06/10024	9kHz - 30MHz	Dec. 14, 2015	Conduction (CO01-NH)
Power Filter	CORCOM	MR12030	N/A	30A*2	NCR	Conduction (CO01-NH)
RF Cable-CON	Suhner Switzerland	RG223/U	CB004	9kHz - 30MHz	Dec. 10, 2015	Conduction (CO01-NH)

Note: Calibration Interval of instruments listed above is one year. NCR: No Calibration Request.

**< Radiated Emission below 1GHz >**

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Open Area Test Site	SPORTON	OATS-10	OS03-NH	30 MHz - 1 GHz 10m, 3m	Oct. 03, 2015	Radiation (OS03-NH)
Amplifier	HP	8447D	2944A08292	0.1 MHz - 1.3 GHz	May 11, 2015	Radiation (OS03-NH)
Spectrum Analyzer	Advantest	R3261C	81720147	9 kHz - 2.6 GHz	Nov. 09, 2015	Radiation (OS03-NH)
Receiver	R&S	ESCS 30	838251/002	9 kHz - 2.75 GHz	Nov. 20, 2015	Radiation (OS03-NH)
Bilog Antenna	CHASE	CBL6112D	25234	30 MHz - 2 GHz	Feb. 28, 2015	Radiation (OS03-NH)
Turn Table	EMCO	2080	9805-2065	0 - 360 degree	NCR	Radiation (OS03-NH)
Antenna Mast	EMCO	2075	9804-2151	1 m - 4 m	NCR	Radiation (OS03-NH)
RF Cable-R10m	HSCN	RG213U	2X11N	30 MHz - 1 GHz	Aug. 05, 2015	Radiation (OS03-NH)

Note: Calibration Interval of instruments listed above is one year. NCR: No Calibration Request.



**< EMS >**

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
ESD Simulator	SCHAFFNER	NSG 437	192	Air: 0 ~ 30kV Contact: 0 ~ 30kV	Oct. 03, 2015	ESD
RS immunity Test system	ROHDE& SCHWARZ	RSF	RS-01	80M~3GHz	Apr. 21, 2015	RS
Amplifier	AMPLIFIER& RESEARCH	250W 1000AM	0332909	80MHz ~ 1GHz	Mar. 19, 2015	RS
DUAL DIRECTIONAL COUPLER	AMPLIFIER& RESEARCH	DC6180A	312453	0.08 ~ 1GHz	Oct. 14, 2015	RS
INTEGRATED MEASUREMENT SYSTEM	ROHDE& SCHWARZ	IMS	100007	9kHz ~ 3GHz	May 08, 2015	RS
NRP-Z91 POWER SENSOR 6GHZ	ROHDE& SCHWARZ	NRP-Z91 1168.8004.02	100095	9kHz ~ 3GHz	May 08, 2015	RS
Antenna	FRANKONIA	BTA-L	02002L	26MHz ~ 1GHz	May 05, 2015	RS
Probe	ETS-LINDGREN	HI-6005	00069910	0.1MHz ~ 5GHz	Sep. 30, 2015	RS
EFT Generator	TESEQ	FTM3425	0180	0 ~ 4kV	Jan. 18.2016	EFT
SURGE Generator	TESEQ	CWN 3650	0429	0 ~ 6 kV/2Ω 0~ 6 kV/12Ω	Jan. 18.2016	SURGE
Conducted Immunity Test System	TESEQ	NSG4070	34293	9kHz ~ 1GHz	Aug. 23, 2015	CS
Attenuator	BIRD	100-SA-MFB-06	0232	150kHz ~ 230MHz	Aug. 25, 2015	CS
Coupling and Decoupling Network	TESTQ	CDN M016	25101	150kHz ~ 230MHz	Jul. 22, 2015	CS
Magnetic field Immunity Loop	FCC (KEYTEK)	F-1000-4-8-G-125A	05004	30A//CONTINUOUS 100A/2Hrs 230A/30SEC	Dec. 30, 2015	PFMF
Magnetic Generator	FCC (KEYTEK)	F-1000-4-8/9/10-L-1M	03004	30A//CONTINUOUS 100A/2Hrs 230A/30SEC	Dec. 30, 2015	PFMF
DIP Generator	TESEQ	VAR 3005-S16	0804	230VA/50Hz/60Hz 0%Open/5S 0%Short/5S 40%/0.10S 70%/0.01S	Jan. 18.2016	DIP
Harmonic/Flicker Test System	SCHAFFNER	CCN1000-1	72471	4000VA 16A PEAK	May 23, 2015	Harmonics, Flicker
AC Power Source	TESEQ	NSG 1007	1510A00144	16A PEAK	May 23, 2015	Harmonics, Flicker

Note: Calibration Interval of instruments listed above is one year.

## 19. Uncertainty of Test Site

### Emission Test Measurement Uncertainty

Test Items	Test Site No.	Uncertainty	Remark
Conducted Emissions	CO01-NH	± 2.6dB	Confidence levels of 95%
Radiated Emissions below 1GHz	OS03-NH	± 2.9dB	Confidence levels of 95%

### Immunity Test Measurement Uncertainty

#### ◆ ESD Immunity (IEC 61000-4-2)

#### Negative Discharge Current

From Standard			
2kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	7.5	4	2
Min	6.75	2.8	1.4
Max	8.25	5.2	2.6
Tolerance in %	10%	30%	30%

From calibration certificate					
Measured First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. -5%
7.48	7.85	4.2	4.41	2.01	2.11
	6.75		2.8		1.4
	8.25		5.2		2.6

From Standard			
4kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	15	8	4
Min	13.5	5.6	2.8
Max	16.5	10.4	5.2
Tolerance in %	10%	30%	30%

Measured First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
15.12	15.88	8.03	8.43	3.68	3.86
	13.5		5.6		2.8
	16.5		10.4		5.2

From Standard			
6kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	22.5	12	6
Min	20.25	8.4	4.2
Max	24.75	15.6	7.8
Tolerance in %	10%	30%	30%

Measured First Peak Current	1st Peak Worst case. -5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
22.78	23.92	12.37	12.99	5.45	5.72
	20.25		8.4		4.2
	24.75		15.6		7.8



**Negative Discharge Current**

From Standard			
8kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	30	16	8
Min	27	11.2	5.6
Max	33	20.8	10.4
Tolerance in %	10%	30%	30%

From calibration Certificate					
First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
30.26	31.77	16.13	16.94	7.39	7.76
	27		11.2		5.6
	33		20.8		10.4

**Negative Discharge Voltage**

Standard Parameters			
Indicated Voltage.	Tolerance.	Max.	Min.
kV	%	kV	kV
2	10	2.20	1.80
4	10	4.40	3.60
6	10	6.60	5.40
8	10	8.80	7.20
15	10	16.50	13.50

Measured Values
kV
2.05
4.027
5.955
7.916
14.839

**Negative Rise Time**

Standard Parameters	
T max.	1ns
T min	0.7ns

Measured Values			
Indicated Voltage.	Measured Rise Time.	Worst Case max. +6%	Worst Case min. -6%
2kV	0.851	0.902	0.799
4kV	0.780	0.827	0.733
6kV	0.750	0.795	0.705
8kV	0.772	0.818	0.726

It has been demonstrated that the ESD generator meets the specified requirements in the standard with at least a 95% confidence

**◆ RF Radiated Immunity (IEC 61000-4-3)**

Symbol	Source of Uncertainty	Value	Probability distribution	Divisor	$u_i(y)$
$F_{SM}$	Felds Strength monitor	1.5	Normal 2	2.000	0.75
$FS_{AW}$	Field Strength acceptability window	0.50	Rectangular	1.732	0.29
PAH	Power Amplifier Harmonics	0.50	Rectangular	1.732	0.29
$R_S$	Measurement System Repeatability	0.50	normal 1	1.000	0.50
$R_{EUT}$	Repeatability of EUT	0.00	normal 1	1.000	0.00
$u_c(F_S)$	Combined Standard Uncertainty	-	normal	-	0.83
$U(F_S)$	<b>Expanded Uncertainty</b>	-	<b>normal k= 2</b>		<b>1.66</b>

Specified Level (V/m)	Test level (V/m)
For 1 Volts	1.25
For 3 Volts	3.33
For 10 Volts	11.22

**◆ EFT/BURST Immunity (IEC 61000-4-4)**
**Voltage Output**

Standard Parameters				Measured Values
Indicated Voltage.	Tolerance.	Max.	Min.	
kV	%	kV	kV	kV
0.5	10	0.55	0.45	0.489
1	10	1.1	0.9	1.006
2	10	2.2	1.8	2.016
4	10	4.4	3.6	3.830
- 0.5	10	- 0.55	- 0.45	- 0.489
- 1	10	- 1.1	- 0.9	- 0.972
- 2	10	- 2.2	- 1.8	- 1.961
- 4	10	- 4.4	- 3.6	- 3.770

**Spike frequency**

Standard Parameters					Measured Values
Indicated Voltage.		Tolerance.	Max.	Min.	
kV	kHz	%	kHz	kHz	kHz
0.5	5	10	5.5	4.5	5.00
1	5	10	5.5	4.5	4.98
2	5	10	5.5	4.5	4.98
4	2.5	10	2.75	2.25	2.49
4	5	10	5.5	4.5	5.01

**Burst width**

Standard Parameters					Measured Values
Indicated Voltage.		Tolerance.	Max.	Min.	
kV	ms	%	ms	ms	ms
0.5	15	20	18	12	14.97
1	15	20	18	12	14.94
2	15	20	18	12	14.91
4	15	20	18	12	14.95

**Burst period**

Standard Parameters					Measured Values
Indicated Voltage.		Tolerance.	Max.	Min.	
kV	ms	%	ms	ms	ms
0.5	300	20	360	240	299.7
1	300	20	360	240	300.5
2	300	20	360	240	299.2
4	300	20	360	240	300.2

It has been demonstrated that the EFT/BURST generator meets the specified requirements in the standard with at least a 95% confidence

**◆ Surge Immunity (IEC 61000-4-5)**
**Surge Voltage Output**

Standard Parameters				Measured Values
Indicated Voltage.	Tolerance.	Max.	Min.	
kV	%	kV	kV	kV
0.5	10	0.55	0.45	0.488
1	10	1.1	0.9	0.964
2	10	2.2	1.8	1.984
4	10	4.4	3.6	3.94
6	10	6.6	5.4	5.91
- 0.5	10	- 0.55	- 0.45	- 0.484
- 1	10	- 1.1	- 0.9	- 0.977
- 2	10	- 2.2	- 1.8	- 1.992
- 4	10	- 4.4	- 3.6	- 3.95
- 6	10	- 6.6	- 5.4	- 5.91

**Output Wave**

Standard Parameters			Measured Values
+ 6 kV			
	Max.	Min.	
Rise Time	1.56 $\mu$ s	0.84 $\mu$ s	1.24 $\mu$ s
Duration Time	60 $\mu$ s	40 $\mu$ s	52.83 $\mu$ s
+ 6 kV			
Rise Time	1.56 $\mu$ s	0.84 $\mu$ s	1.30 $\mu$ s
Duration Time	60 $\mu$ s	40 $\mu$ s	54.72 $\mu$ s

It has been demonstrated that the Surge generator meets the specified requirements in the standard with at least a 95% confidence

◆ **RF Conducted Immunity (IEC 61000-4-6)**

Symbol	Source of Uncertainty	Value	Probability distribution	Divisor	$u_i(y)$
$S_A$	Spectrum Analyzer	1.50	Rectangular	1.732	0.87
$C_C$	Current coil Calibration	1.00	normal 2	2.000	0.50
$M$	Mismatch	-0.5	U-shaped	1.414	-0.35
$M$	Mismatch	-0.3	U-shaped	1.414	-0.35
$R_S$	Measurement System Repeatability	0.50	normal 1	1.000	0.50
$R_{EUT}$	Repeatability of EUT	0.00	normal 1	1.000	0.00
$u_c(F_S)$	Combined Standard Uncertainty	-	normal	-	1.57
$U(F_S)$	Expanded Uncertainty	-	normal k= 2		3.14

Specified Level (V)	Test level (V)
For 1 Volts	1.30
For 3 Volts	3.88
For 10 Volts	12.15

◆ **Magnetic Field Immunity (IEC 61000-4-8)**

**Current output**

Standard Parameters					Measured Values
Magnetic Field Strength	Output Current	Tolerance.	Max.	Min.	
A/m	A	%	A	A	
1	6	5	6.3	3.8	
3	50	5	52.5	47.5	49.0
10	180	5	189	171	188.0

It has been demonstrated that the Magnetic generator meets the specified requirements in the standard with at least a 95% confidence



**◆ Voltage Variation Immunity (IEC 61000-4-11)**

**Short Dip period**

Standard Parameters					Measured Values
Degree	Duration	Tolerance.	Max.	Min.	
	ms	%	ms	ms	
90	4	5	4.2	3.8	
180	8	5	8.4	7.6	
270	12	5	12.6	11.4	
360	16	5	16.8	15.2	

**Long Dip period**

Standard Parameters					Measured Values
Degree	Duration	Tolerance.	Max.	Min.	
	ms	%	ms	ms	
90	16	5	16.8	15.2	
180	50	5	55	45	
270	100	5	110	90	
360	150	5	165	135	

**It has been demonstrated that the Dip generator meets the specified requirements in the standard with at least a 95% confidence**

## Appendix A. Test Photos

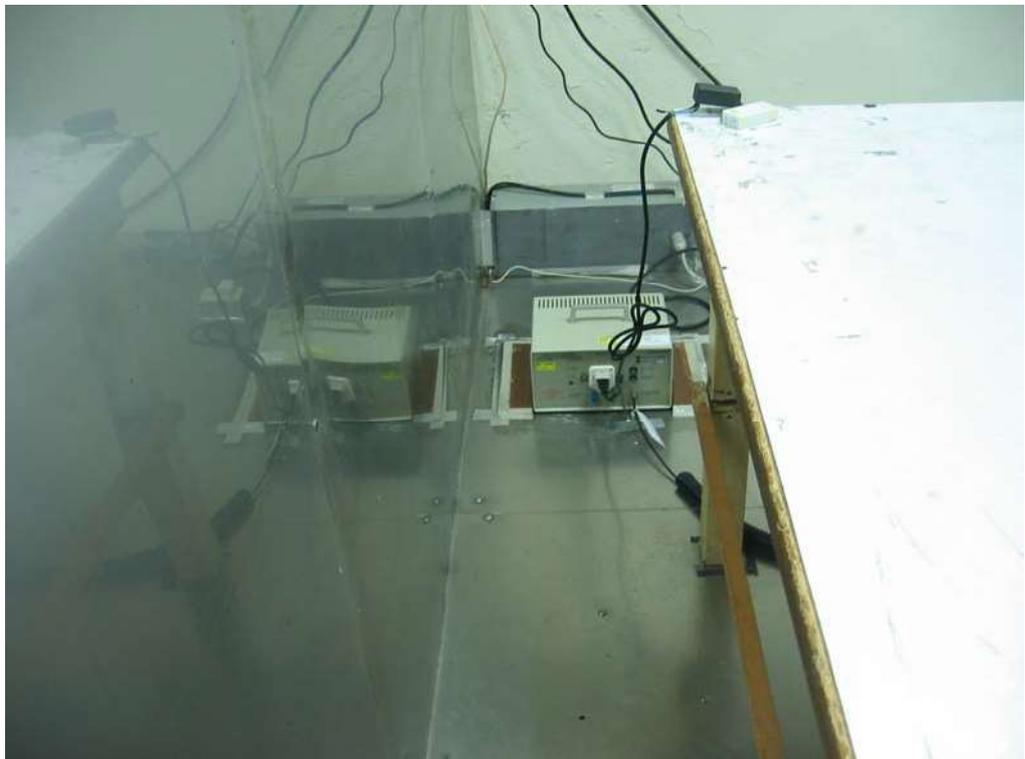
### 1. Photographs of Conducted Emissions Test Configuration

EN 55022

Front view



Rear view



**Side view**

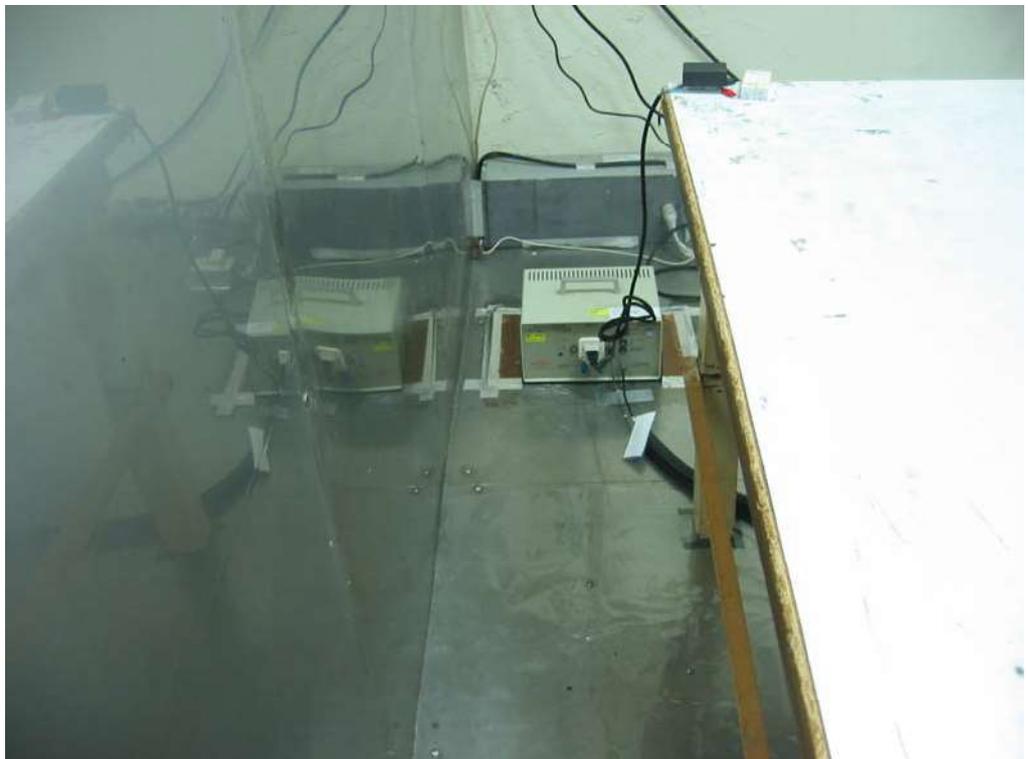


**EN 55032**

**Front view**



**Rear view**



**Side view**



## 2. Photographs of Radiated Emissions Test Configuration

For radiated emissions below 1GHz  
EN 55022

Front view



Rear view



EN 55032

Front view



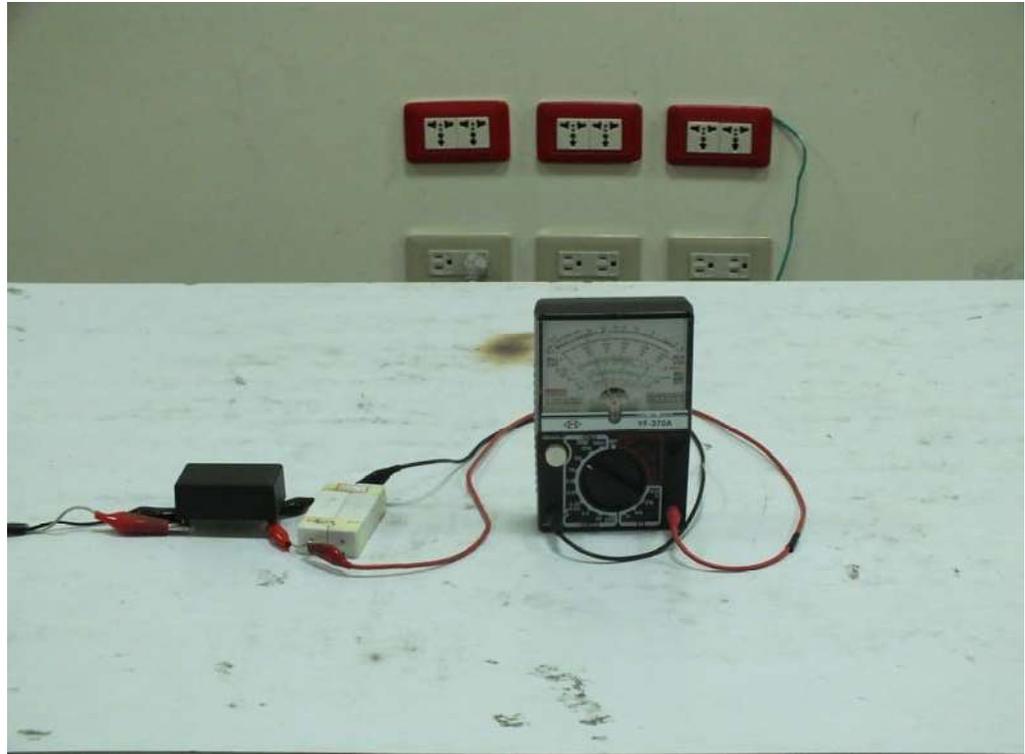
Rear view



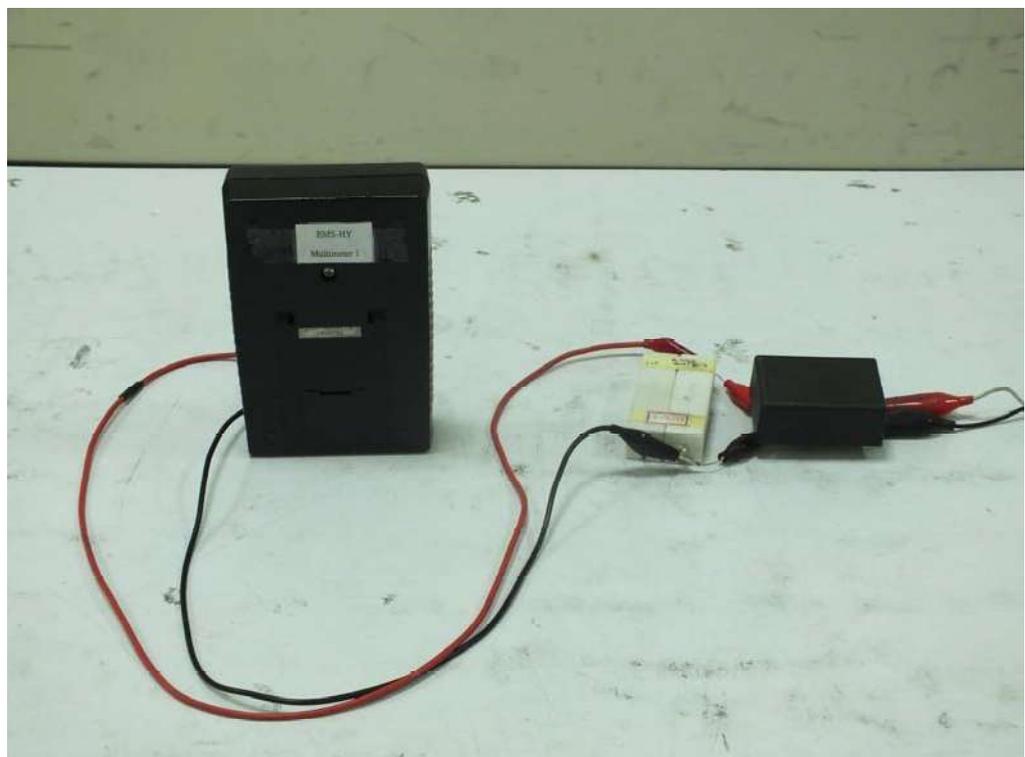
**3.**

#### 4. Photographs of Harmonic, Flicker, Surge, Dip Test Configuration

Front view



Rear view



## 5. Photographs of ESD Immunity Test Configuration

Front view

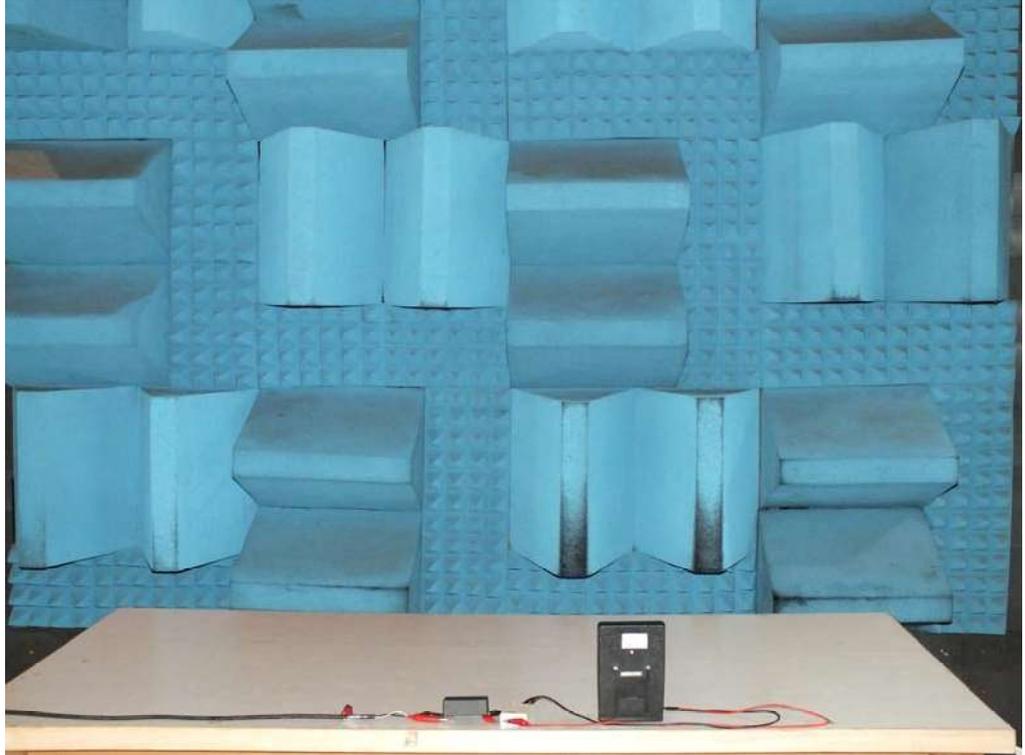


Rear view

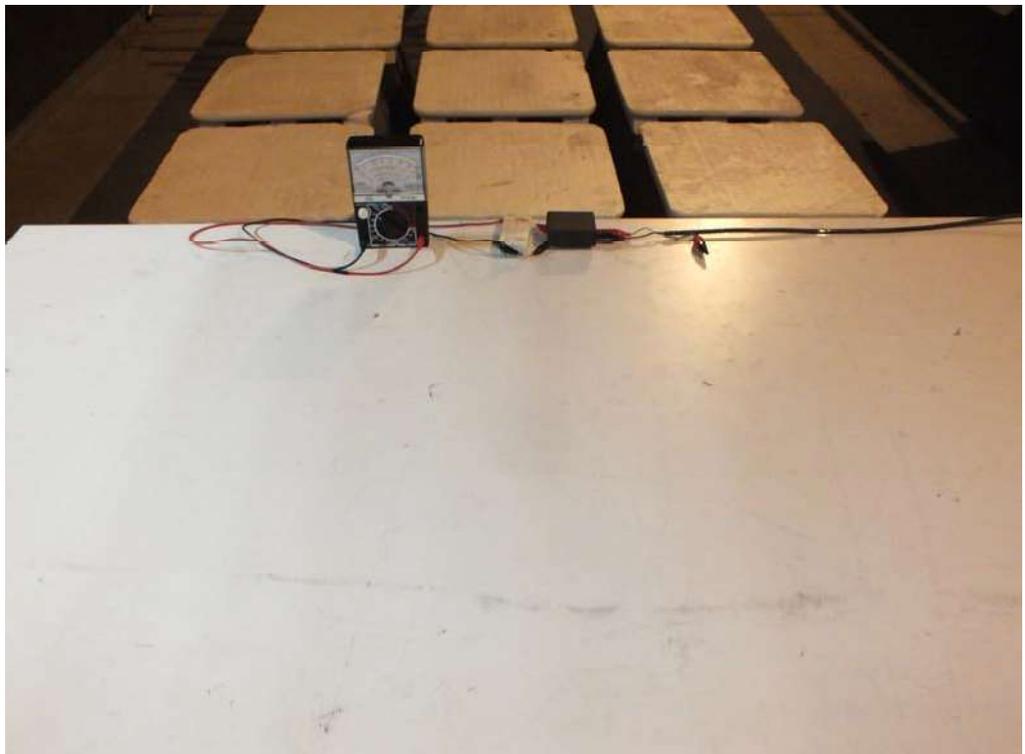


## 6. Photographs of RS Immunity Test Configuration

Front view

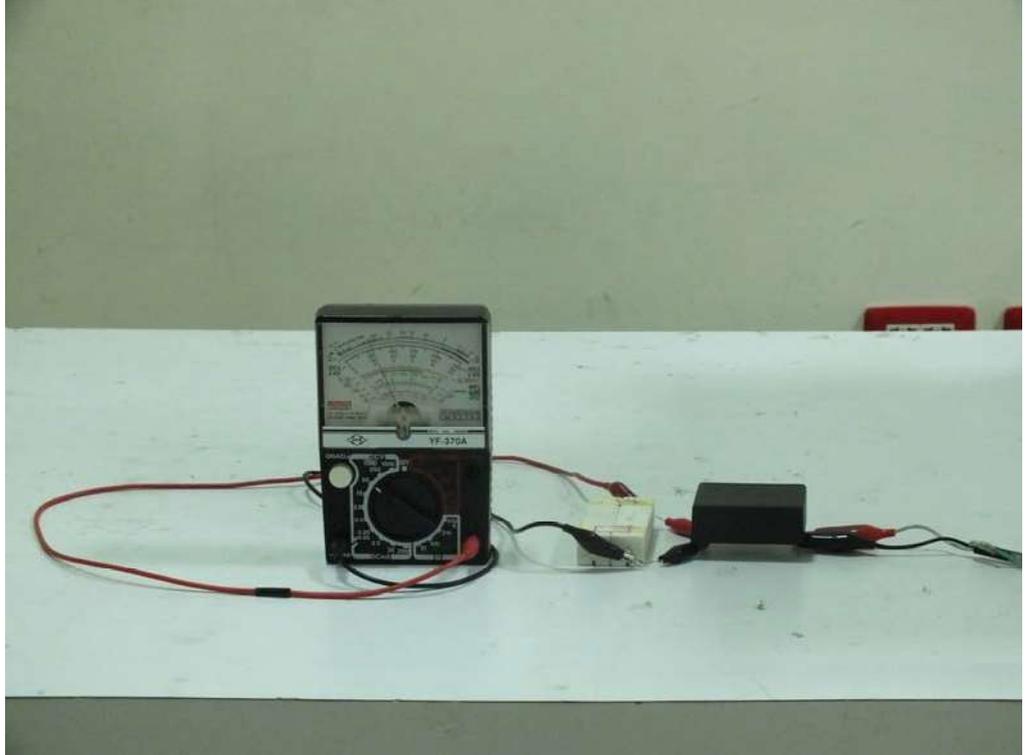


Rear view

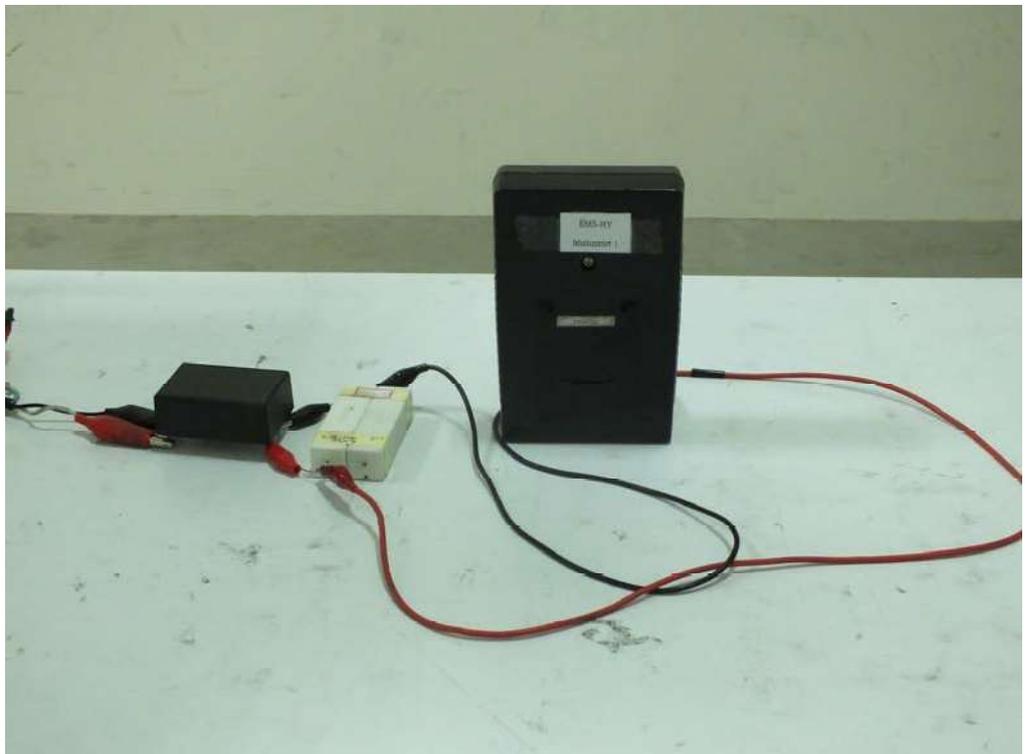


## 7. Photographs of EFT Test Configuration

Front view

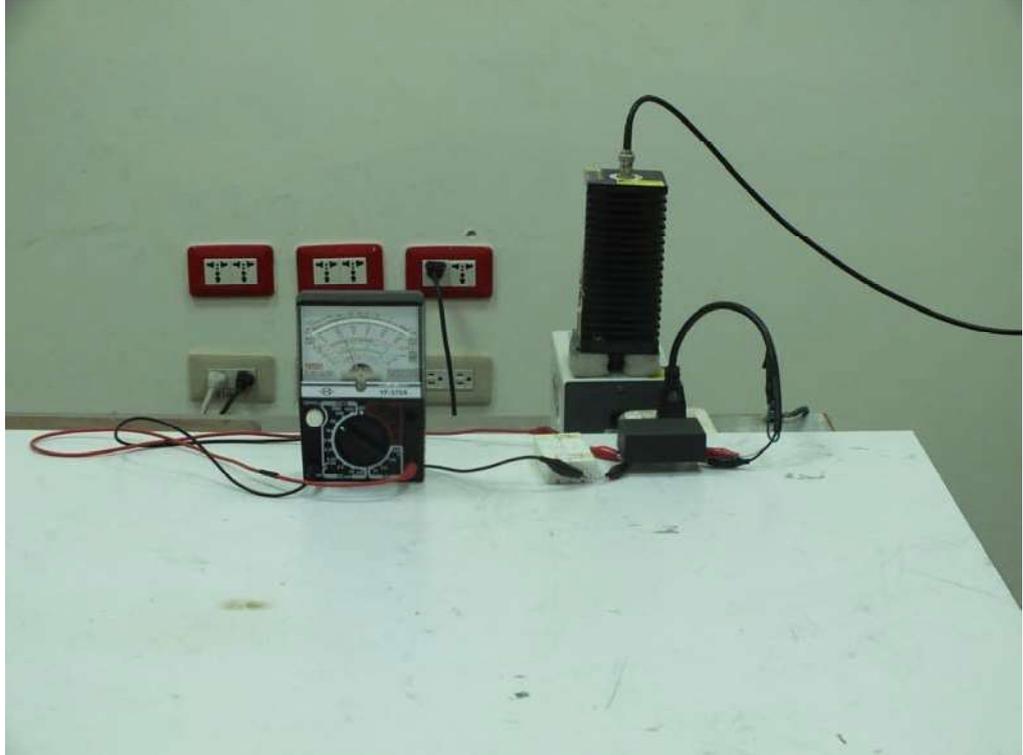


Rear view

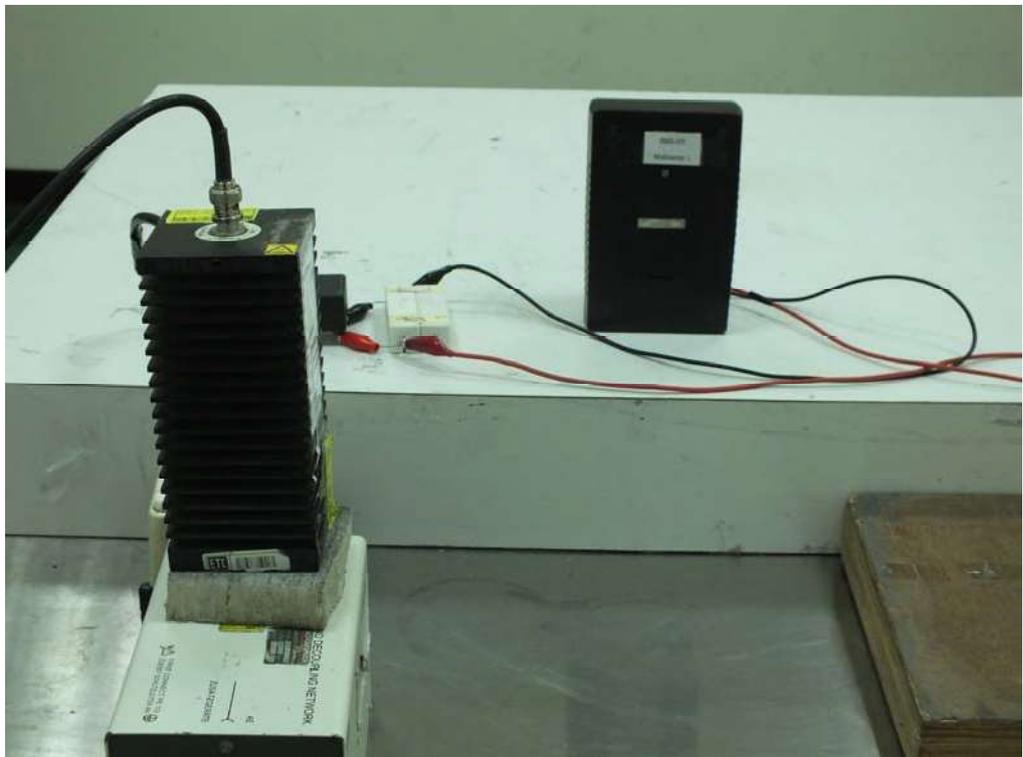


## 8. Photographs of CS Immunity Test Configuration

Front view

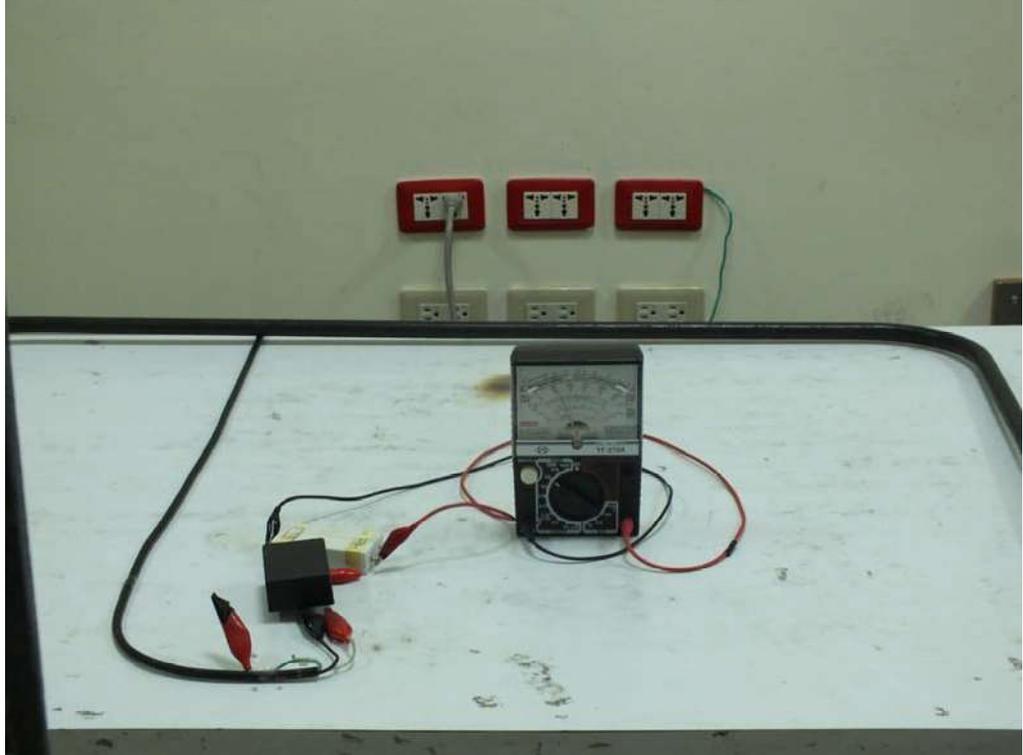


Rear view

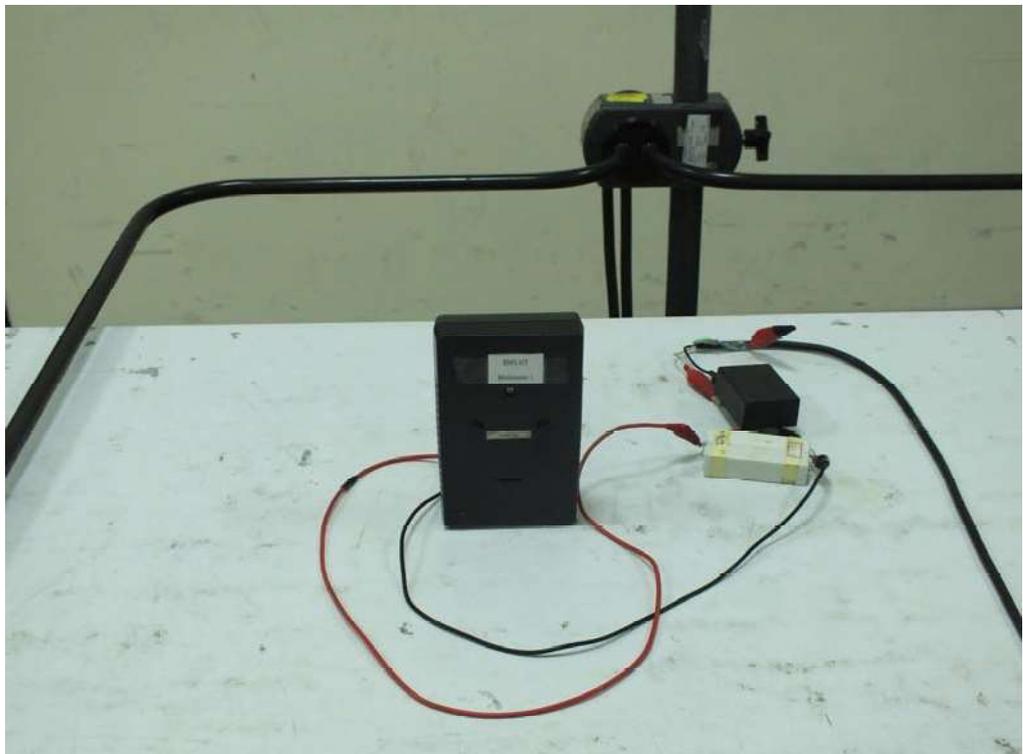


## 9. Power Frequency Magnetic Field immunity Measurement (PFMF)

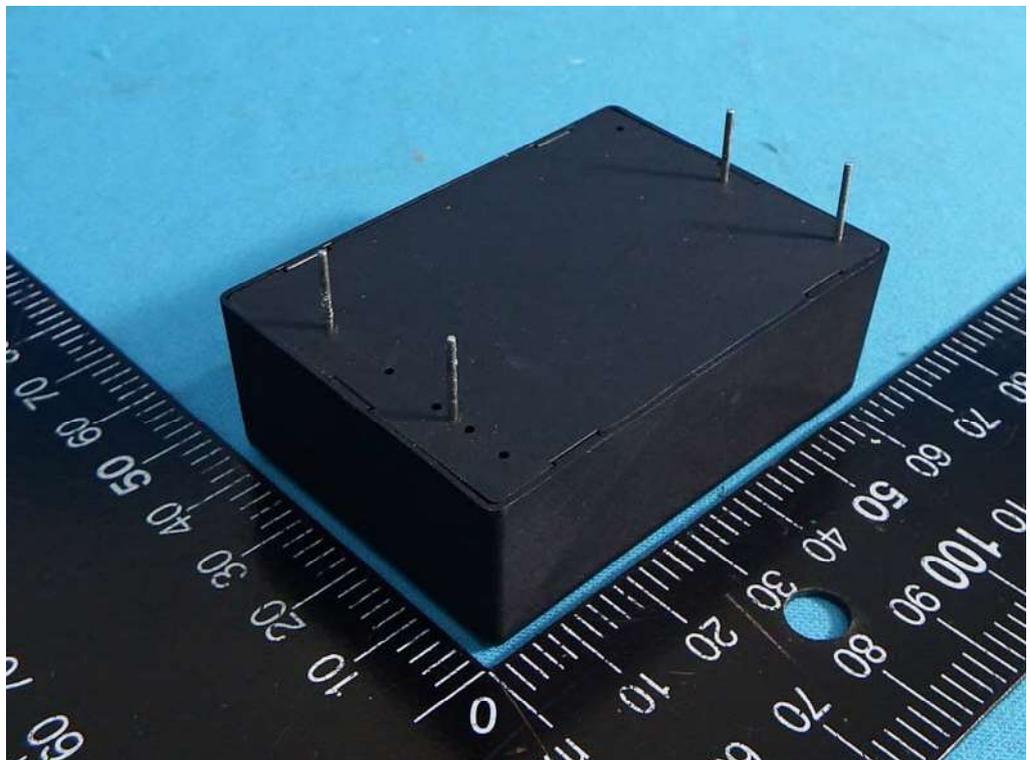
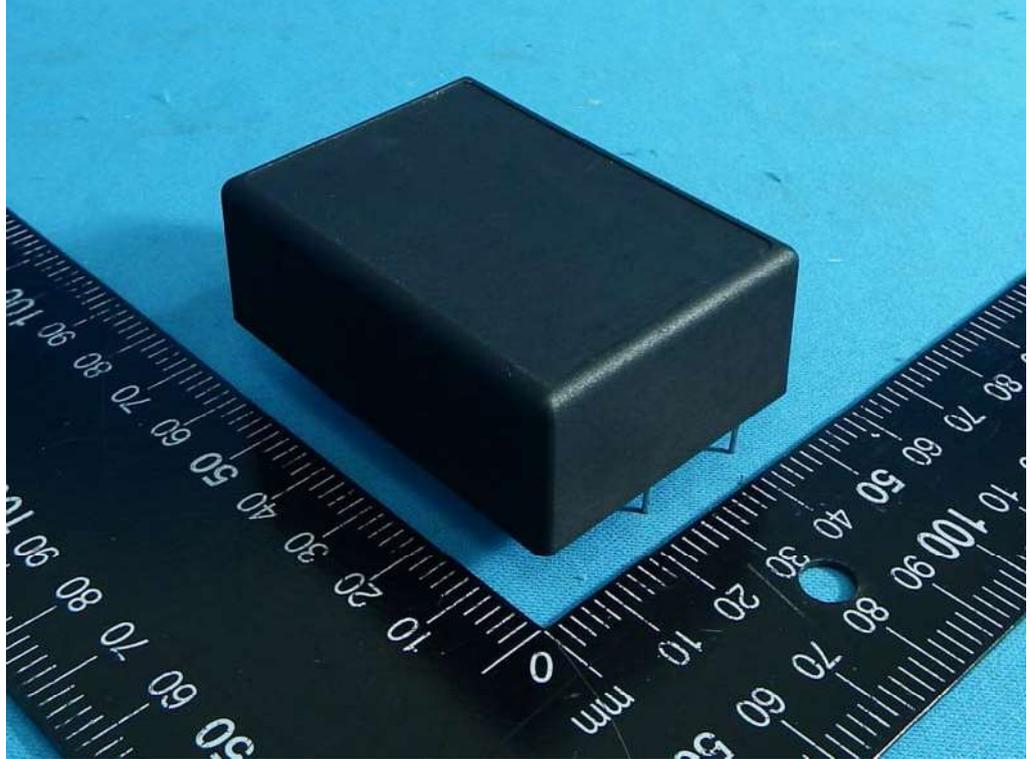
Front view



Rear view



APPENDIX B. Photographs of EUT



## Appendix C. Attachment of Report for Additional Measurement Data

The equipment of this attachment is the same as the Equipment under Test of original test report no. **EC5D1413-01**, except for the following difference.

Original Information:

**Equipment : AC-DC Converter**

**Model No. : TMG 30103 、 TMG 30105 、 TMG 30112 、 TMG 30115 、 TMG 30124**

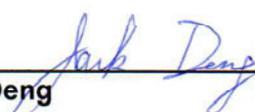
**Applicant : Traco Electronic AG**

Sihlbruggstrasse 111, 6340 Baar, Switzerland

Additional Information:

1) EN 61000-6-2 data.

This attachment should be filed together with original test report, Report No.: **EC5D1413-01** for reference.

  
\_\_\_\_\_  
**Jack Deng**  
**Engineering Manager**

### **SPORTON INTERNATIONAL INC.**

No. 52, Hwa Ya 1st Rd., Hwa Ya Technology Park,  
Kwei-Shan District, Taoyuan City, Taiwan, R.O.C.

Tel: 886-3-327-3456

Fax: 886-3-327-0973

## C.1 Test Configuration of Equipment under Test

### C.1.1 Test Manner

- a. The EUT has been associated with personal computer and peripherals pursuant to European Standard EN 61000-6-2.
- b. The equipment under test were performed the following test modes:

Test Items	Description of test modes
Harmonic and Flicker Emissions	Mode 1. FULL LOAD
EMS	Mode 1. FULL LOAD

- c. Frequency range investigated: CS 150 kHz to 80 MHz, RS 80 MHz to 2,700 MHz.

### C.1.2 Description of Test System

No.	Peripheral	Manufacturer	Model Number	Cable / Spec. Description
For Local				
1.	Load	■	4.8Ω/30W	-
2.	Multimeter	YU FONG	YF—370A	Probe Cable, Non-Shielded, 1.0m

## C.2 Harmonic Current Emissions Measurement

### C.2.1 Standard

- Standard : EN 61000-3-2

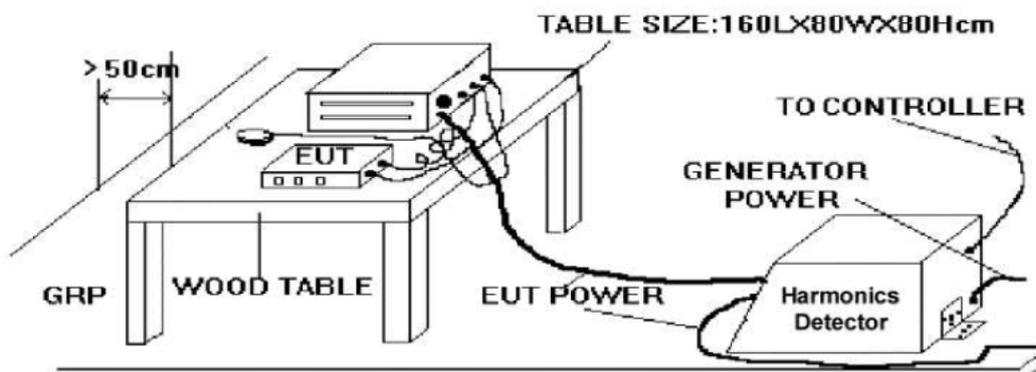
### C.2.2 Test Procedure

The measured values of the harmonics components of the input current, including line current and neutral current, shall be compared with the limits given in Clause 7 of EN 61000-3-2.

### C.2.3 Test Equipment Settings

Harmonic Parameters	Setting
Line Voltage	230 V
Line Frequency	50 Hz
Device Class	-
Current Measurement Range	High
Measurement Delay	10.0 seconds
Test Duration	10.0 minutes
Class determination Pre-test Duration	10.0 seconds

### D.2.4 Typical Test Setup Layout of Harmonic Current Emissions



### C.2.5 Test Result of Harmonic Current Emissions

<b>V_RMS (Volts):</b>	<b>230.42</b>	<b>Frequency(Hz):</b>	<b>50.00</b>
<b>I_Peak (Amps):</b>	<b>1.248</b>	<b>I_RMS (Amps):</b>	<b>0.290</b>
<b>I_Fund (Amps):</b>	<b>0.136</b>	<b>Crest Factor:</b>	<b>4.308</b>
<b>Power (Watts):</b>	<b>30.1</b>	<b>Power Factor:</b>	<b>0.457</b>

As specified on clause 7 of EN 61000-3-2:2014, the limits are not specified for equipment with a rated power of 75W or less.

### C.3 Voltage Fluctuations and Flicker Measurement

#### C.3.1 Standard

- Product Standard : EN 61000-3-3

#### C.3.2 Test Procedure

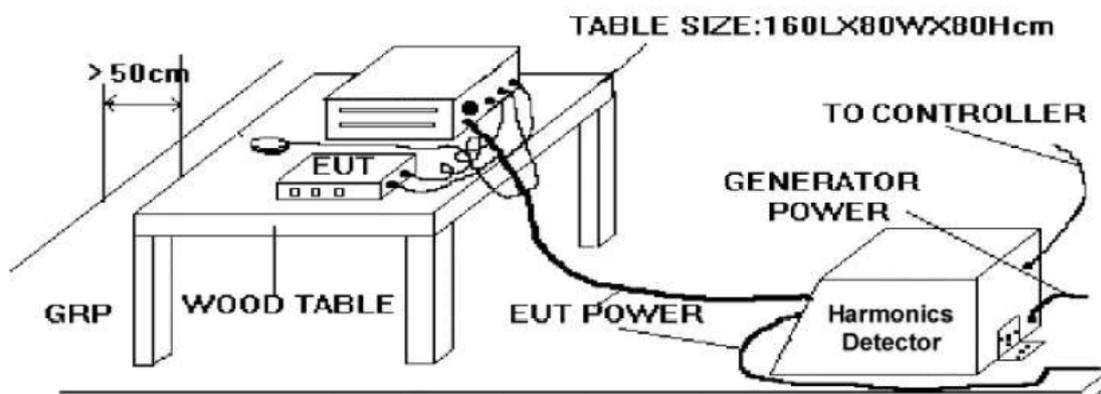
The equipment shall be tested under the conditions of **Clause 5**.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of  $\pm 8\%$  is achieved during the whole assessment procedure.

#### C.3.3 Test Equipment Settings

Flicker Parameters	Setting
Line Voltage	230 V
Line Frequency	50 Hz
Measurement Delay	10.0 seconds
Pst Integration Time	10.0 minutes
Pst Integration Periods	1
Test Duration	10.0 minutes

#### C.3.4 Typical Test Setup Layout of Voltage Fluctuations and Flicker



**C.3.5 Test Result of Voltage Fluctuation and Flicker**

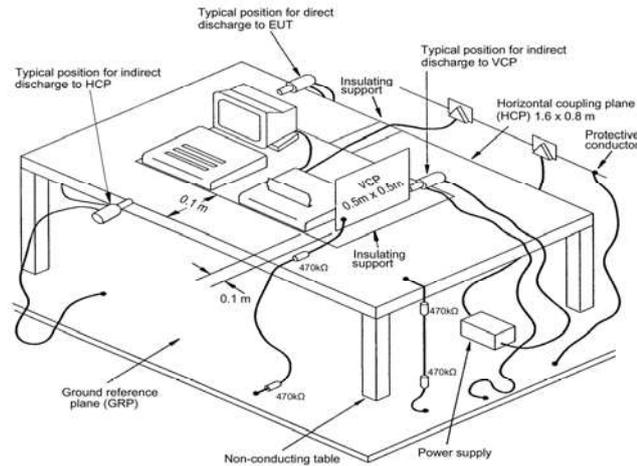
Test mode	Mode 1
Final Test Result	<b>PASS</b>
Temperature	22 °C
Relative Humidity	46 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 05, 2016
Test Engineer	Jaily

Vrms at the end of test (Volt):	230.36 <sub>u</sub>		
Highest dt (%):	0.00	Test limit (%):	3.30 Pass
T-max (mS):	0	Test limit (mS):	500.0 Pass
Highest dc (%):	0.00	Test limit (%):	3.30 Pass
Highest dmax (%):	0.00	Test limit (%):	4.00 Pass
Highest Pst (10 min. period):	0.248	Test limit:	1.000 Pass

### C.4 Electrostatic Discharge Immunity Measurement (ESD)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	A $\pm 2 / \pm 4 / \pm 8$ kV for air discharge
	A $\pm 2 / \pm 4$ kV for contact discharge
Required Performance Criteria	B $\pm 2 / \pm 4 / \pm 8$ kV for air discharge
	B $\pm 2 / \pm 4$ kV for contact discharge
Basic Standard	IEC 61000-4-2
Product Standard	EN 61000-6-2:2005
Level	3 for air discharge
	2 for contact discharge
Test Voltage	$\pm 2 / \pm 4 / \pm 8$ kV for air discharge
	$\pm 2 / \pm 4$ kV for contact discharge
Discharge Impedance	330 ohm / 150 pF
Temperature	20 °C
Relative Humidity	45 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	The test points, please refer to section C.4.5

### C.4.1 Test Setup



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- b. AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

#### **C.4.2 Test Setup for Tests Performed in Laboratory**

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the SPORTON EMC LAB., we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1 m minimum was provided between the EUT and the wall of the Lab., and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2 m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resistor located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8 m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m x 0.5 m.

### C.4.3 ESD Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
  - ambient temperature: 15 °C to 35 °C;
  - relative humidity : 30 % to 60 %;
  - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
  - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
  - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
  - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

**C.4.4 Test Severity Levels**

## C.4.4.1 Contact Discharge

Level	Test Voltage (kV) of Contact discharge
1	±2
2	±4
3	±6
4	±8
X	Specified
Remark : "X" is an open level.	

## C.4.4.2 Air Discharge

Level	Test Voltage (kV) of Air Discharge
1	±2
2	±4
3	±8
4	±15
X	Specified
Remark : "X" is an open level.	

**C.4.5 Test Points**

C.4.5.1 Test Result of Air Discharge

Because the sample can't discharge by itself, we determine the status is pass.

C.4.5.2 Test Result of Contact Discharge

**Direct discharge**

No Direct discharge

***Indirect discharge to HCP and VCP***

Test Point	No. of Discharges	Contact Discharge/Pointed Tip				Test Record
		+2kV	-2kV	+4kV	-4kV	
HCP (At Front)	10	A	A	A	A	Normal
HCP (At Left)	10	A	A	A	A	Normal
HCP (At Right)	10	A	A	A	A	Normal
HCP (At Rear)	10	A	A	A	A	Normal
VCP (At Front)	10	A	A	A	A	Normal
VCP (At Left)	10	A	A	A	A	Normal
VCP (At Right)	10	A	A	A	A	Normal
VCP (At Rear)	10	A	A	A	A	Normal

**C.5 Radio Frequency Electromagnetic Field Immunity Measurement (RS)**

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	A
Required Performance Criteria	A
Basic Standard	IEC 61000-4-3
Product Standard	EN 61000-6-2:2005
Level	3 / 2 / 1
Frequency Range	80-1000 MHz, 1400-2700 MHz
Field Strength	10 V/m (unmodulated, r.m.s) 80% AM (1 kHz) – for 80-1000 MHz 3 V/m (unmodulated, r.m.s) 80% AM (1 kHz) – for 1400-2000 MHz 1 V/m (unmodulated, r.m.s) 80% AM (1 kHz) – for 2000-2700 MHz
Temperature	23 °C
Relative Humidity	47 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	Normal

### C.5.1 Test Record

Frequency Band: 80-1000 MHz

Sides of the EUT have been exposed to the field	Antenna positioned	Test field strength Level	Test field strength (V/m)	Test Record
Front	Vertical	3	10	Normal (No influencing)
	Horizontally	3	10	Normal (No influencing)
Left	Vertical	3	10	Normal (No influencing)
	Horizontally	3	10	Normal (No influencing)
Back	Vertical	3	10	Normal (No influencing)
	Horizontally	3	10	Normal (No influencing)
Right	Vertical	3	10	Normal (No influencing)
	Horizontally	3	10	Normal (No influencing)

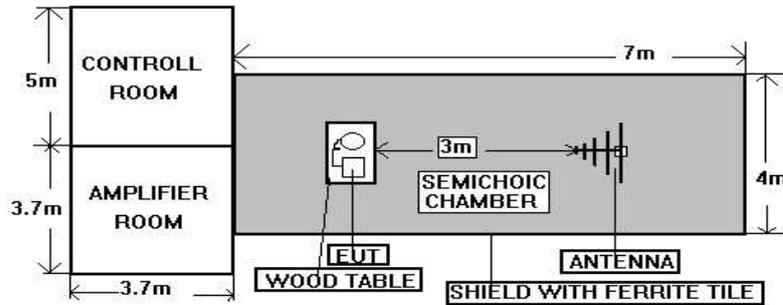
Frequency Band: 1400-2000 MHz

Sides of the EUT have been exposed to the field	Antenna positioned	Test field strength Level	Test field strength (V/m)	Test Record
Front	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Left	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Back	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Right	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)

Frequency Band: 2000-2700 MHz

Sides of the EUT have been exposed to the field	Antenna positioned	Test field strength Level	Test field strength (V/m)	Test Record
Front	Vertical	1	1	Normal (No influencing)
	Horizontally	1	1	Normal (No influencing)
Left	Vertical	1	1	Normal (No influencing)
	Horizontally	1	1	Normal (No influencing)
Back	Vertical	1	1	Normal (No influencing)
	Horizontally	1	1	Normal (No influencing)
Right	Vertical	1	1	Normal (No influencing)
	Horizontally	1	1	Normal (No influencing)

**C.5.2 Test Setup**



**NOTE :** The SPORTON 7m x 4m x 4m semi-anechoic chamber is compliance with the sixteen point's uniform field requirement as stated in IEC 61000-4-3 Section 6.2.

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

**C.5.3 Test Procedure**

- a. The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- b. The bilog antenna which is enabling the complete frequency range of 80-1000MHz, 1400-2700MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- c. The test is normally performed with the generating antenna facing each of four sides of the EUT. The polarization of the field generated by the broadband (bilog) antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.
- d. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- e. At each of the above conditions, the frequency range is swept 80-1000MHz, 1400-2700MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of  $1.5 \times 10^{-3}$  decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

**C.5.4 Test Severity Levels**

Frequency Band : 80-1000MHz, 1400-2700MHz

Level	Test field strength (V/m)
1	1
2	3
3	10
X	Specified
Remark : "X" is an open class.	

### C.6 Electrical Fast Transient/Burst Immunity Measurement (EFT/BURST)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	A
Required Performance Criteria	B
Basic Standard	IEC 61000-4-4
Product Standard	EN 61000-6-2:2005
Level	on input power ports -3
Test Voltage	on input power ports -- $\pm 0.5 / \pm 1.0 / \pm 2.0$ kV
Impulse wave shape	5/50 ns (Tr/Th)
Impulse frequency	5 kHz
Test Repetition Rate	1 time / minute
Temperature	22 °C
Relative Humidity	46 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	Normal

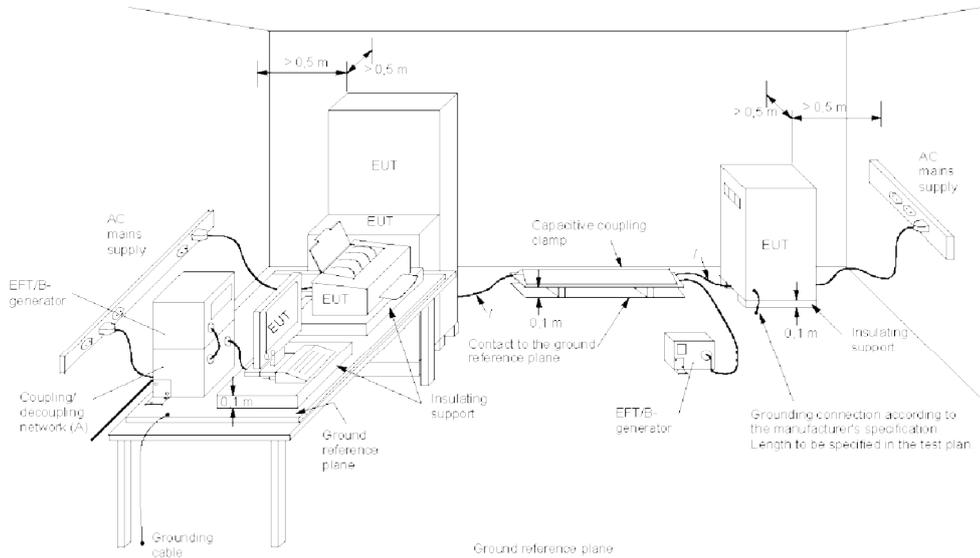
#### C.6.1 Test Record

■ Input power port:

Test Location	Polarity	Test Level	Voltage (Peak)	Test Record
L+N	+	3	0.5 / 1.0 / 2.0 kV	Normal (No influencing)
	-	3	0.5 / 1.0 / 2.0 kV	Normal (No influencing)

Remark : PE = Earth reference

**C.6.2 Test setup**



**Key**

- l* length between clamp and the EUT to be tested (should be 0,5 m ± 0,05 m)
- (A) location for supply line coupling
- (B) location for signal lines coupling

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The EUT was placed on a ground reference plane and was insulated from it by an insulating support about 0.1 m thick. If the EUT is table-top equipment, it was located approximately 0.8 m above the GRP. The GRP was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. It shall project beyond the EUT by at least 0.1 m on all sides and connected to the protective earth. In the SPORTON EMC LAB., We provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system. The EUT was arranged and connected according to its functional requirements. The minimum distance between the EUT and other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. using the coupling clamp, the minimum distance between the coupling plates and all other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. The length of the signal and power lines between the coupling device and the EUT was 1 m or less.

### C.6.3 Test on Power Line

- a. The EFT/B-generator was located on the GRP. The length from the EFT/B-generator to the EUT as not exceeds 1 m.
- b. The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.

### C.6.4 Test on Communication Lines

- a. The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
- b. The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.

### C.6.5 Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
  - ambient temperature: 15 °C to 35 °C;
  - relative humidity : 45 % to 75 %;
  - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria :
  - Normal performance within the specification limits.
  - Temporary degradation or loss of function or performance which is self-recoverable.
  - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
  - Degradation or loss of function which is not recoverable due to damage of equipment (components).

**C.6.6 Test Severity Levels**

The following test severity levels are recommended for the fast transient/burst test :

Open circuit output test voltage $\pm 10\%$		
Level	On Input power ports	On signal port and telecommunication ports
1	0.5 kV	0.25 kV
2	1.0 kV	0.50 kV
3	2.0 kV	1.00 kV
4	4.0 kV	2.00 kV
X	Specified	Specified

Remark : " X " is an open level.  
The level is subject to negotiation between the user and the manufacturer or is specified by the manufacturer.

### C.7 Surge Immunity Measurement

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<b>A</b> for Input Power Port
Required Performance Criteria	B for Input power ports,
Basic Standard	IEC 61000-4-5
Product Standard	EN 61000-6-2:2005
Surge wave form (Tr/Th)	1,2/50 ( 8/20 ) $\mu$ s for input power ports 1,2/50 ( 8/20 ) $\mu$ s for input signal ports
Level	on input power ports – 3
Test Voltage	on Input Power Port -- $\pm 1.0 / \pm 2.0$ kV
Phase Angle	0°, 90°, 180°, 270°
Number of surges	5 positive and 5 negative pulses
Pulse Repetition Rate	1 time / min. (maximum)
Temperature	22 °C
Relative Humidity	46 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	Please refer to section C.7.1

**C.7.1 Test Record**

■ Input power ports:

Test Location	Voltage (kV)	Polarity	Phase Angle				Test Record
			0°	90°	180°	270°	
L - N	1.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)
L - PE	2.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)
N - PE	2.0	+	A	A	A	A	Normal (No influencing)
		-	A	A	A	A	Normal (No influencing)

Remark : PE = Earth reference

**C.7.2 Test Severity Levels**

Level	Open-circuit test voltage, $\pm 10\%$ , kV
1	0.5
2	1.0
3	2.0
4	4.0
x	Specified

Remark : " X " is an open level.  
This level can be specified in the product specification.

### C.7.3 Test Procedure

a. Climatic conditions

The climatic conditions shall comply with the following requirements :

- ambient temperature : 15 °C to 35 °C
- relative humidity : 10 % to 75 %
- atmospheric pressure : 86 kPa to 106 kPa ( 860 mbar to 1060 mbar )

b. Electromagnetic conditions

The electromagnetic environment of the laboratory shall not influence the test results.

c. The test shall be performed according the test plan that shall specify the test set-up with

- generator and other equipment utilized;
- test level ( voltage/current );
- generator source impedance;
- internal or external generator trigger;
- number of tests : at least five positive and five negative at the selected points;
- repetition rate : maximum 1/min.
- inputs and outputs to be tested;
- representative operating conditions of the EUT;
- sequence of application of the surge to the circuit;
- phase angle in the case of a.c. power supply;
- actual installation conditions, for example :  
AC : neutral earthed,  
DC : ( + ) or ( - ) earthed to simulated the actual earthing conditions.

d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave ( positive and negative ).

e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.

f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.

g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level ( let-through level ) of the primary protection.

h. If the actual operating signal sources are not available, they may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according the test plan.

i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test previously unstressed equipment shall be used to the protection devices shall be replaced.

#### **C.7.4 Operating Condition**

Full system

### C.8 Conducted Disturbances Induced by Radio-Frequency Field Immunity Measurement (CS)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	A
Required Performance Criteria	A
Basic Standard	IEC 61000-4-6
Product Standard	EN 61000-6-2:2005
Level	3
Test Voltage	10 V (unmodulated, r.m.s), 80% AM (1 kHz)
Frequency Range	0.15 MHz to 80 MHz
Test Port	on Input Power Port
Dwell time	2.9 seconds
Frequency step size	1 %
Coupling mode	CDN M016 M2 for AC power Port
Temperature	23 °C
Relative Humidity	45 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	Normal

#### C.8.1 Test Record

Test Port	Test field strength level	Test field strength (V rms)	Test Record
Input power port	3	10	Normal (No influencing)

#### C.8.2 Test Severity Levels

Level	Voltage Level (EMF)
1	1 V rms
2	3 V rms
3	10 V rms
x	Specified

Remark : " X " is an open level.  
This level can be specified in the product specification.

### C.8.3 Operating Condition

Full system

### C.8.4 Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- g. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- h. The use of special exercising programs is recommended.
- i. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- j. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

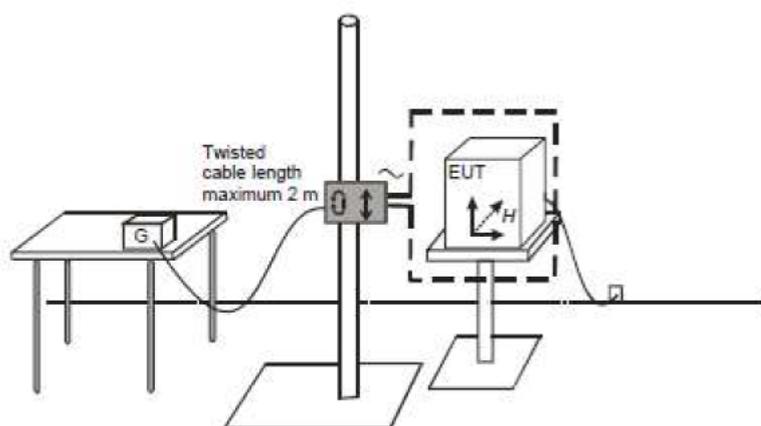
### C.9 Power Frequency Magnetic Field immunity Measurement (PFMF)

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	A
Required Performance Criteria	A
Basic Standard	IEC 61000-4-8
Product Standard	EN 61000-6-2:2005
Temperature	22 °C
Relative Humidity	46 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 06, 2016
Test Engineer	Jaily
Observation	Please refer to section D.9.1

#### C.9.1 Test Record

Power Frequency Magnetic Field	Testing duration	Coil Orientation	Test Record
50/60Hz, 30A/m	1.0 Min	X-axis	Normal (No influencing)
50/60Hz, 30A/m	1.0 Min	Y-axis	Normal (No influencing)
50/60Hz, 30A/m	1.0 Min	Z-axis	Normal (No influencing)

#### C.9.2 Test Setup



EUT : Equipment under test    G : Test Generator

**C.10 Voltage Dips and Voltage Interruptions Immunity Measurement (DIP)**

Test mode	Mode 1
Final Test Result	<b>PASS</b>
Pass Performance Criteria	<u>C</u> for voltage interruption, <u>A/A/A</u> for voltage dips
Required Performance Criteria	C for voltage interruption, B/B/C for voltage dips
Basic Standard	IEC 61000-4-11
Product Standard	EN 61000-6-2:2005
Test Port	Input power ports
Phase Angle	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°, 360°
Temperature	22 °C
Relative Humidity	46 %
Atmospheric Pressure	101 kPa
Test Date	Apr. 05, 2016
Test Engineer	Jaily
Observation	Please refer to section C.10.1 and C.10.2

**C.10.1 Test Record of Voltage Interruption**

Voltage ( V )	Performance Criterion (Phase Angle)									Residual voltage	Duration (Cycle)
	0°	45°	90°	135°	180°	225°	270°	315°	360°		
100/240	C	C	C	C	C	C	C	C	C	0 %	250/300
Observation	After the interruption, the power of EUT was off. The power of the EUT must be reset by the operator.										

**C.10.2 Test Record of Voltage Dips**

Voltage ( V )	Performance Criterion (Phase Angle)									Residual voltage	Duration (Cycle)
	0°	45°	90°	135°	180°	225°	270°	315°	360°		
100/240	A	A	A	A	A	A	A	A	A	0 %	1
100/240	A	A	A	A	A	A	A	A	A	40 %	10/12
100/240	A	A	A	A	A	A	A	A	A	70 %	25/30
Observation	Normal (No influencing)										

### **C.10.3 Testing Requirement and Procedure**

The test was based on IEC 61000-4-11

### **C.10.4 Test Conditions**

1. Source voltage and frequency : 100/240V, 50Hz, Single phase.
2. Test of interval : 10 sec.
3. Level and duration : Sequency of 3 dips/interrupts.
4. Voltage rise (and fall) time : 1 ~ 5  $\mu$ s.

### **C.10.5 Operating Condition**

Full system

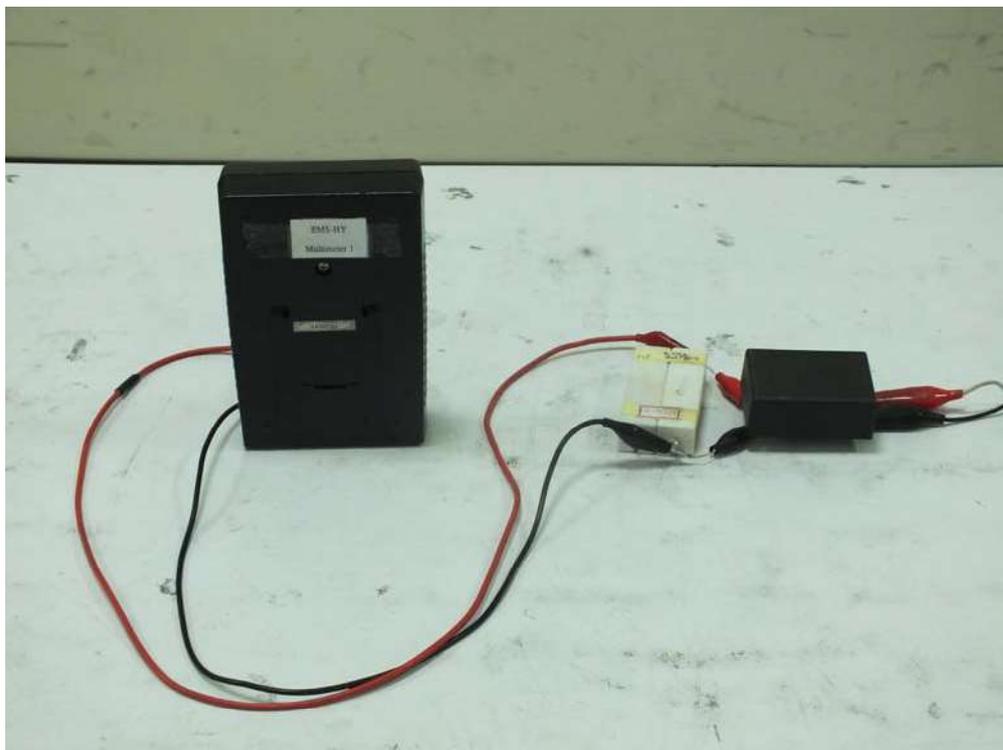
## C.1 Photographs of Test Configuration

### C.1.1 Photographs of Flicker, Surge, Dip Test Configuration

Front view



Rear view



**C.1.2 Photographs of ESD Immunity Test Configuration**

**Front view**

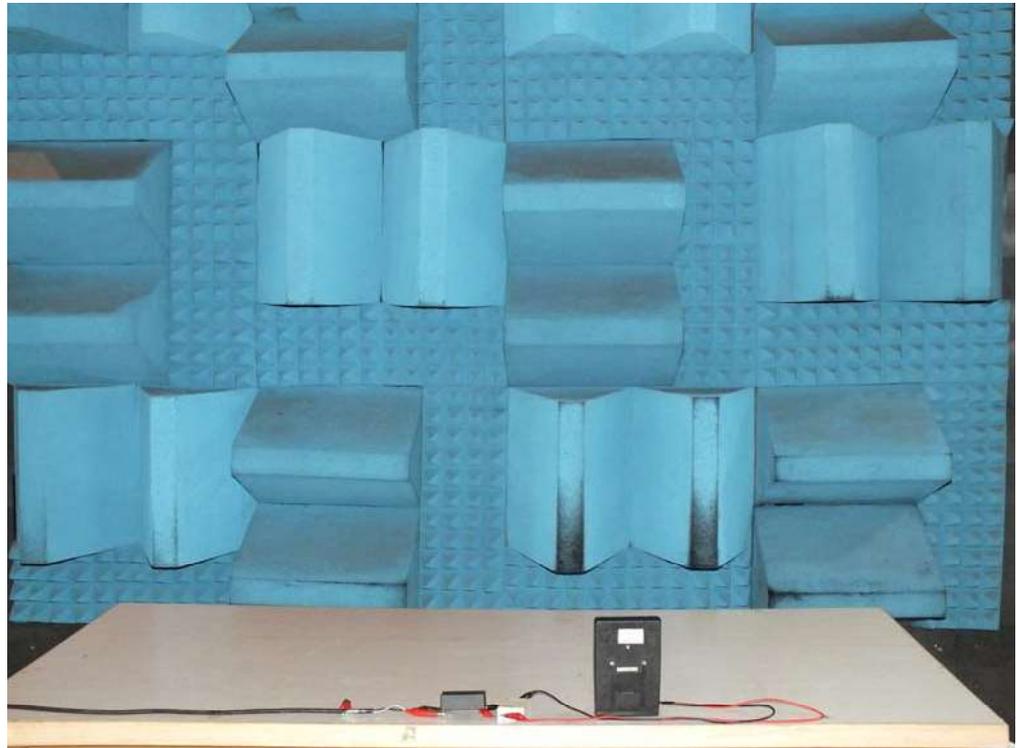


**Rear view**

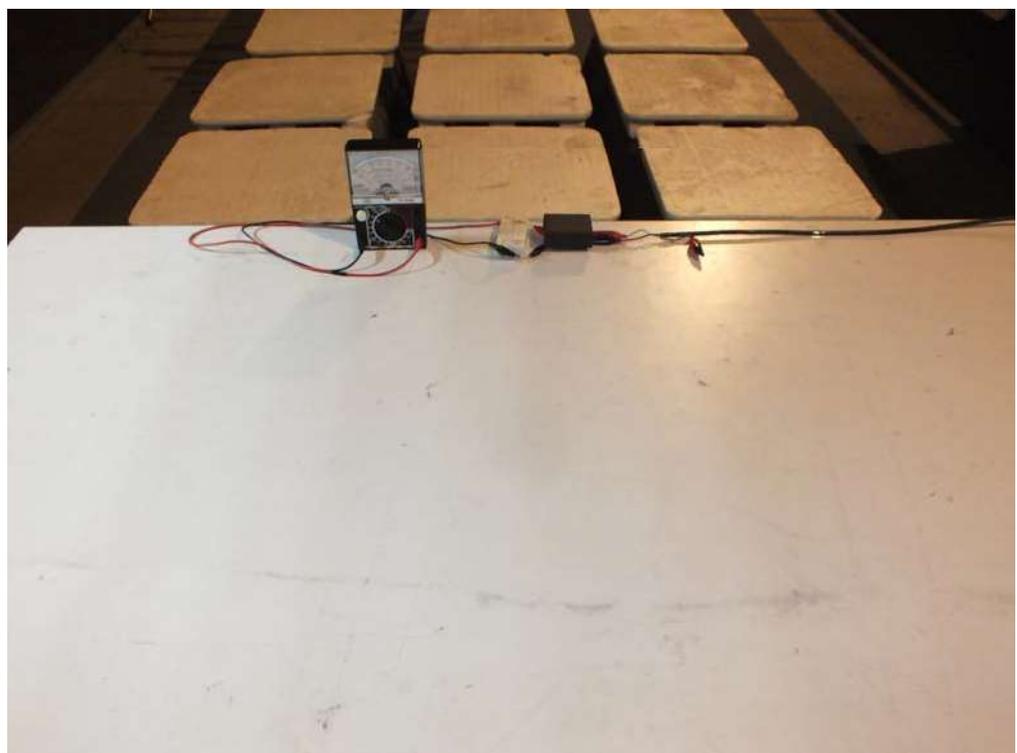


**C.1.3 Photographs of RS Immunity Test Configuration**

**Front view**

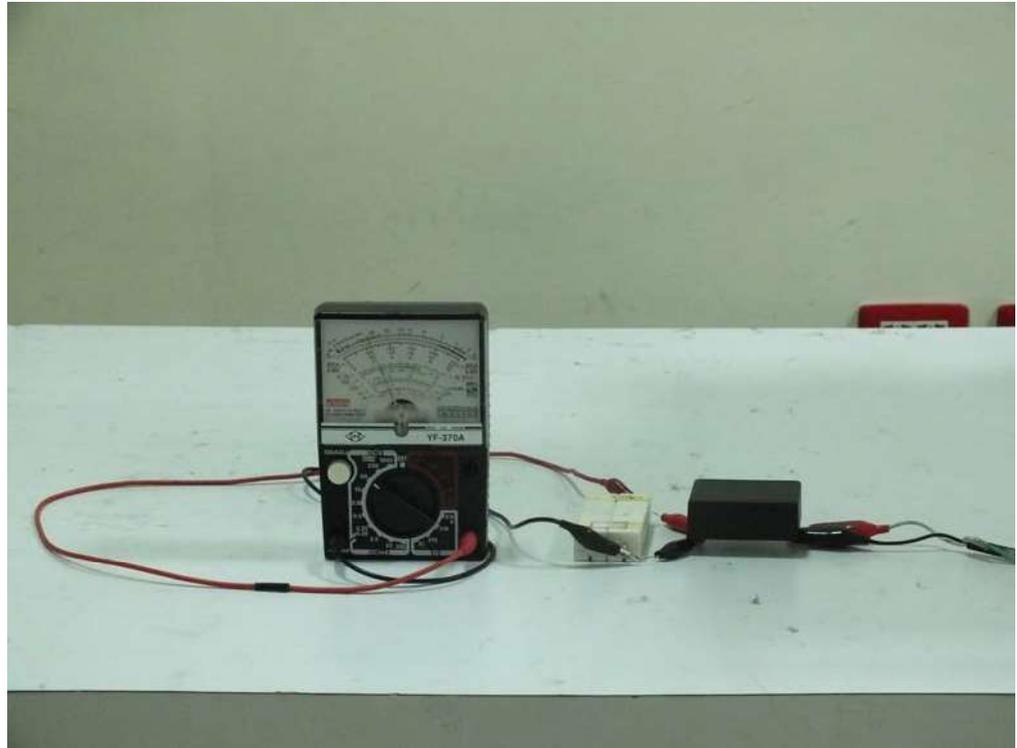


**Rear view**

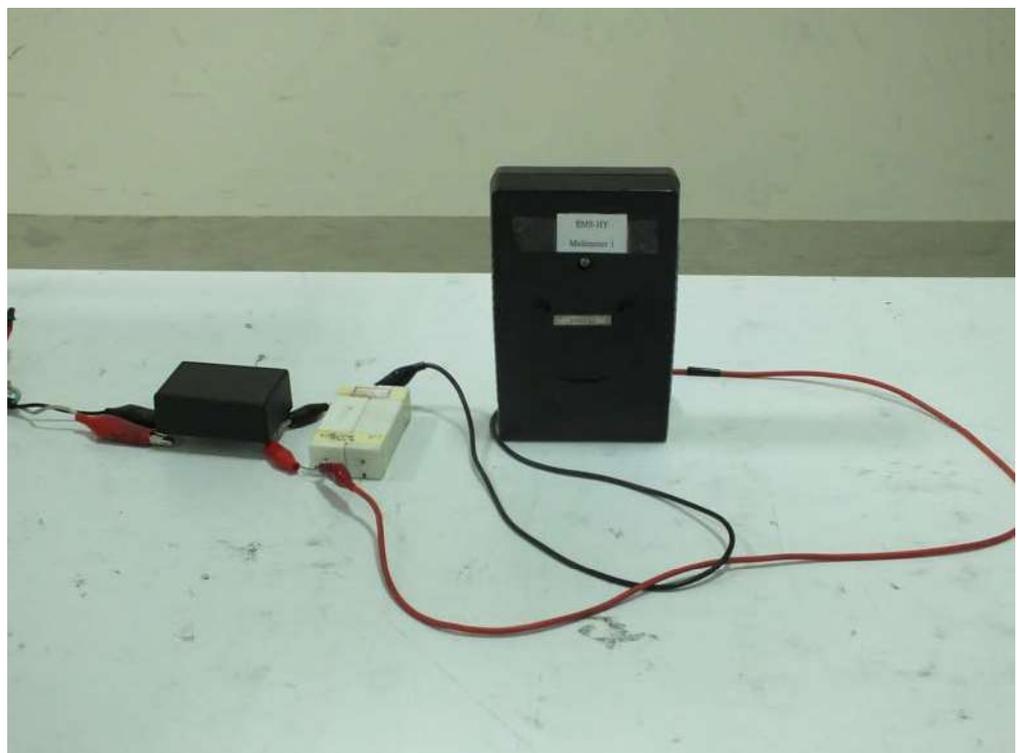


**C.1.4 Photographs of EFT Test Configuration**

**Front view**

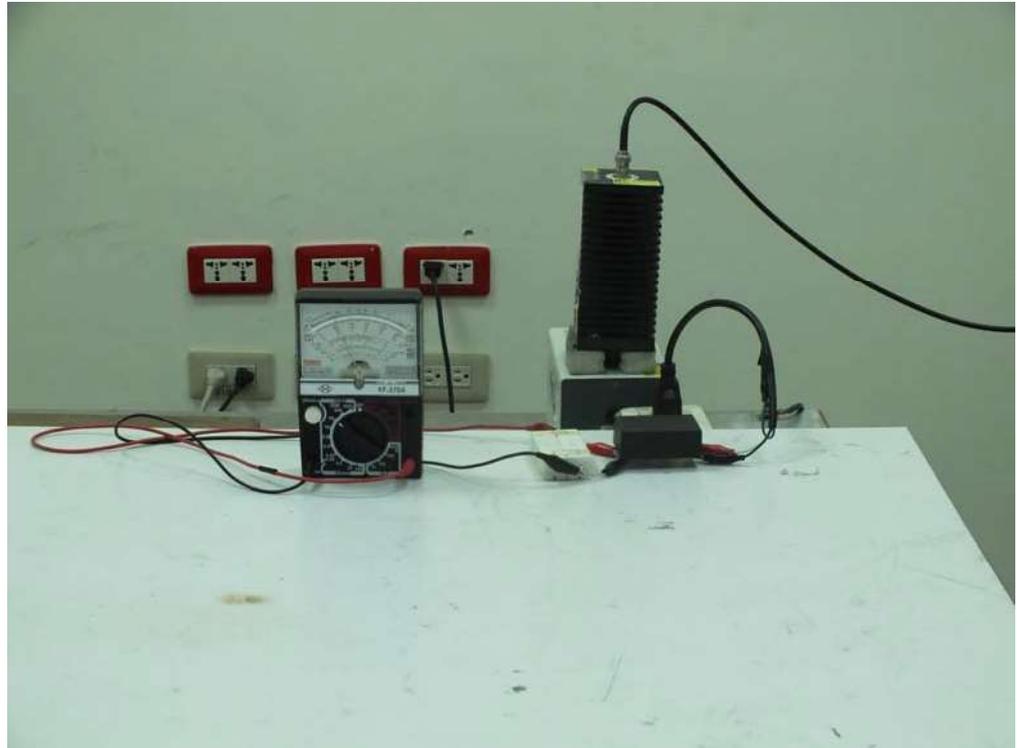


**Rear view**



**C.1.5 Photographs of CS Immunity Test Configuration**

**Front view**



**Rear view**

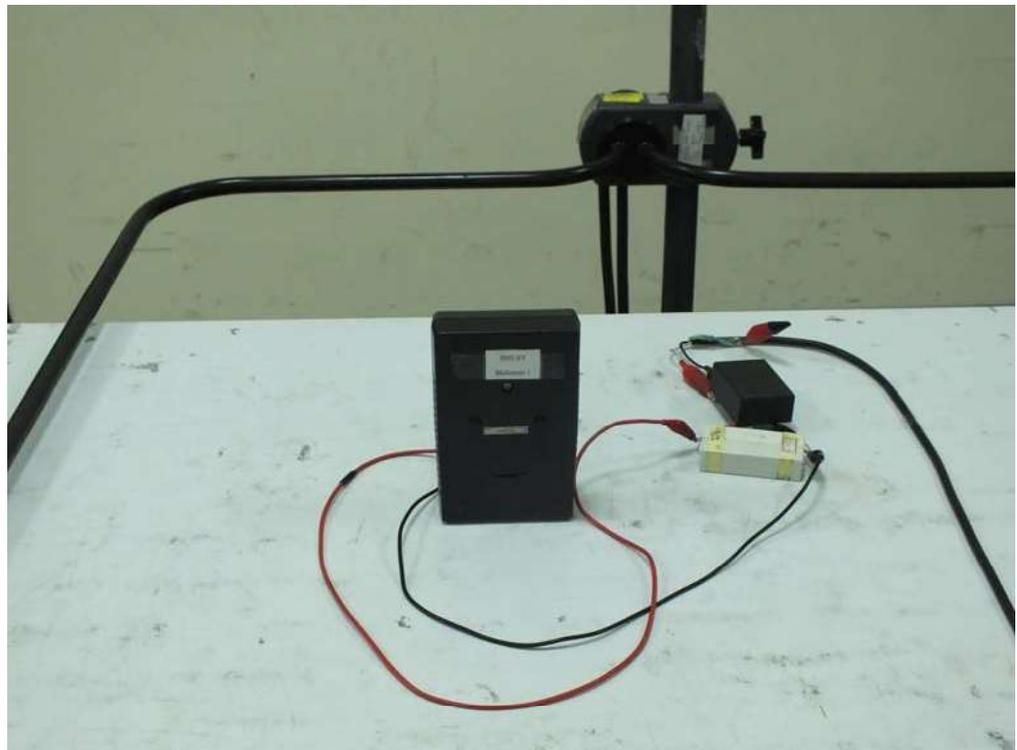


**C.1.6 Power Frequency Magnetic Field immunity Measurement (PFMF)**

Front view



Rear view



## C.2 List of Measuring Equipment Used

### EMS

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
ESD Simulator	SCHAFFNER	NSG 437	192	Air: 0 ~ 30kV Contact: 0 ~ 30kV	Oct. 03, 2015	ESD
RS immunity Test system	ROHDE& SCHWARZ	RSF	RS-01	80M~3GHz	Apr. 21, 2015	RS
Amplifier	AMPLIFIER& RESEARCH	250W 1000AM	0332909	80MHz ~ 1GHz	Mar. 16, 2016	RS
Amplifier	AMPLIFIER& RESEARCH	30S1G3	312505	800M~3GHz	Oct. 14, 2015	RS
DUAL DIRECTIONAL COUPLER	AMPLIFIER& RESEARCH	DC6180A	312453	0.08 ~ 1GHz	Oct. 14, 2015	RS
DUAL DIRECTIONAL COUPLER	AMPLIFIER& RESEARCH	DC7144A	312782	0.8 ~ 4.2GHz	Oct. 14, 2015	RS
INTEGRATED MEASUREMENT SYSTEM	ROHDE& SCHWARZ	IMS	100007	9kHz ~ 3GHz	May 08, 2015	RS
NRP-Z91 POWER SENSOR 6GHZ	ROHDE& SCHWARZ	NRP-Z91 1168.8004.02	100095	9kHz ~ 3GHz	May 08, 2015	RS
Antenna	FRANKONIA	BTA-L	02002L	26MHz ~ 1GHz	May 05, 2015	RS
Antenna	AR	AT4002A	312601	800MHz ~ 5GHz	May 05, 2015	RS
Probe	ETS-LINDGREN	HI-6005	00069910	0.1MHz ~ 5GHz	Sep. 30, 2015	RS
EFT Generator	TESEQ	FTM3425	0180	0 ~ 4kV	Jan.18.2016	EFT
SURGE Generator	TESEQ	CWN 3650	0429	0 ~ 6 kV/2Ω 0~ 6 kV/12Ω	Jan.18.2016	SURGE
Conducted Immunity Test System	TESEQ	NSG4070	34293	9kHz ~ 1GHz	Aug. 23, 2015	CS
Attenuator	BIRD	100-SA-MFB-06	0232	150kHz ~ 230MHz	Aug. 25, 2015	CS
Coupling and Decoupling Network	SCHAFFNER	CDN M016	16688	150kHz ~ 230MHz	Jul. 22, 2015	CS
Magnetic field Immunity Loop	FCC (KEYTEK)	F-1000-4-8-G-125A	05004	30A//CONTINUOUS 100A/2Hrs 230A/30SEC	Dec.30, 2015	PFMF
Magnetic Generator	FCC (KEYTEK)	F-1000-4-8/9/10-L-1M	03004	30A//CONTINUOUS 100A/2Hrs 230A/30SEC	Dec.30, 2015	PFMF
DIP Generator	TESEQ	VAR 3005-S16	0804	230VA/50Hz/60Hz 0%Open/5S 0%Short/5S 40%/0.10S 70%/0.01S	Jan.18.2016	DIP
Harmonic/Flicker Test System	SCHAFFNER	CCN1000-1	72471	4000VA 16A PEAK	May 23, 2015	Harmonics, Flicker
AC Power Source	TESEQ	NSG 1007	1510A00144	16A PEAK	May 23, 2015	Harmonics, Flicker

Note: Calibration Interval of instruments listed above is one year.